# 1715 LCR Digibridge Instruction Manual

Form 150710/A3

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The material in this manual is for informational purposes only and is subject to change, without notice. QuadTech assumes no responsibility for any error or for consequential damages that may result from the misinterpretation of any procedures in this publication.

#### **CAUTION**

Voltage may be present on front and rear panel terminals. Follow all warnings in this manual when operating or servicing this instrument. Substantial levels of energy may be stored in capacitive devices tested by this unit.

Product will be marked with this symbol (ISO#3864) when it is necessary for the user to refer to the instruction manual in order to prevent injury or equipment damage.

Product marked with this symbol (IEC417) indicates presence of direct current.

Product will be marked with this symbol (ISO#3864) when voltages in excess of 1000V are present.

# **Contents**

Specifications .		5			
		•••••			
Safet	y Precaut	ions		11	
Cond	lensed Op	erating I	nstructions	13	
Intro	duction -	Section 1	l		
1.1	Unpacl	king and I	nspection	17	
1.2	Produc	t Overvie	w	17	
1.3	Contro	ls and Ind	icators	18	
	1.3.1	Front Pa	nel Controls and Indicators	18	
	1.3.2	Rear Par	nel Controls and Connectors	19	
1.4	Installa	tion		20	
	1.4.1	Dimensi	ons	20	
	1.4.2		ent Positioning		
	1.4.3	Power R	equirements	20	
	1.4.4		rispection		
		•			
	ration - So				
2.1			entions		
2.2					
2.3			P		
			on		
	2.3.2		Manage		
	2.3.3	System (	Configuration		
		2.3.3.1	BEEPER	29	
		2.3.3.2	KEY LOCK	29	
		2.3.3.3	SOUND MODE	29	
		2.3.3.4	ALARM MODE	30	
		2.3.3.5	HANDLER MODE	30	
		2.3.3.6	GPIB ADDRESS	30	
		2.3.3.7	TRIGGER DELAY	31	
		2.3.3.8	TRIGGER EDGE	31	
		2.3.3.9	LINE FREQUENCY	31	
			BAUD RATE		
2.4	MEAS		Y		
	2.4.1		ency		
	2.4.2	LEVEL			
	2.4.3				
	2.4.4		,		

# **Contents**

<b>Operat</b>	tion - Se	ection 2 - Continued			
2.4	<b>MEAS</b>	DISPLAY Continued			
	2.4.6	TRIGger	.39		
	2.4.7	BINning	.39		
	2.4.8	COMPare	.40		
2.5	MAIN	INDEX	.41		
	2.5.1	BINNING	.41		
	2.5.2	COMPARE	.44		
	2.5.3	CORRECTION	.46		
2.6	Connec	tion to Device Under Test	.50		
2.7	Measur	rement Procedure	.55		
Interfa	ce - Sec	tion 3			
3.1	RS-232	Interface	.57		
	3.1.1	Pin Configuration	.57		
	3.1.2	RS-232 Specifications	.57		
	3.1.3	RS-232 Interface Commands			
	3.1.4	Sample Quick Basic Program	.59		
3.2	IEEE-4	88 Interface			
	3.2.1	Pin Configuration	.60		
	3.2.2	IEEE-488 Interface Function Codes and Messages	.62		
	3.2.3	IEEE-488 Interface Commands	.64		
	3.2.4	IEEE-488 Command Format	.66		
	3.2.5	IEEE-488 Commands - Detailed	.67		
	3.2.6	Binning Example	.75		
	3.2.7	Compare Example			
	3.2.8	Sample IEEE BASIC Program	.77		
3.3	Handler Interface				
	3.3.1	Handler Pin Assignments for Binning Operation	.80		
	3.3.2	Handler Pin Assignments for Compare Operation			
Service		bration - Section 4			
4.1		1	.83		
4.2	Instrum	nent Return	.83		
4.3	Calibra	tion	.83		
	4.3.1	1715 Verification Procedure	.84		
	132	1715 Varification Data Shoot			

# Warranty



QuadTech warrants that Products are free from defects in material and workmanship and, when properly used, will perform in accordance with QuadTech's applicable published specifications. If within one (1) year after original shipment it is found not to meet this standard, it will be repaired, or at the option of QuadTech, replaced at no charge when returned to a QuadTech service facility.

Changes in the Product not approved by QuadTech shall void this warranty.

QuadTech shall not be liable for any indirect, special or consequential damages, even if notice has been given of the possibility of such damages.

This warranty is in lieu of all other warranties, expressed or implied, including, but not limited to any implied warranty or merchantability of fitness for a particular purpose.

## **SERVICE POLICY**

QuadTech's service policy is to maintain product repair capability for a period of at least five (5) years after original shipment and to make this capability available at the then prevailing schedule of charges.

# **Specifications**

**Primary Parameters:** Ls, Lp, Cs, Cp, Rs, Rp and |Z|

 $\begin{array}{lll} Ls, \, Lp: & 0.01 \mu H - 9.999 kH \\ Cs, \, Cp: & 0.01 pF - 99.999 mF \\ Rs, \, Rp: & 0.1 m\Omega - 99.99 M\Omega \\ |\, Z\,|: & 0.1 m\Omega - 99.99 M\Omega \end{array}$ 

**Secondary Parameters:** D, Q,  $\theta$ , Xs, Rs and Rp

D: 0.0001 - 9999Q: 0.0001 - 9999θ:  $-180.00^{\circ} - 180.00^{\circ}$ Xs:  $0.1 \text{m}\Omega - 99.99 \text{M}\Omega$ Rs, Rp:  $0.1 \text{m}\Omega - 99.99 \text{M}\Omega$ 

**Measurement Accuracy:** Basic LCR: 0.2% (1kHz/1V rms) Basic DQ: ±0.002

**Measurement Rate:** Fast: 25 measurements/second

Medium: 8 measurements/second Slow: 2 measurements/second

**Measurement Mode:** Continuous or Trigger (INT, EXT or Manual)

**Trigger Delay:** 0 - 9999 ms

**Ranging:** Automatic or Hold Range

**Test Voltage:**  $0.25V \text{ and } 1.0V \text{ RMS}, \pm (10\% + 3\text{mV})$ 

**Test Frequency:** 4 User Selectable Test Frequencies: 100Hz, 120Hz, 1kHz and

10kHz (9.6kHz)

Accuracy:  $\pm 0.2\%$ 

**Source Impedance:**  $25\Omega$ ,  $100\Omega$ ,  $1k\Omega$ ,  $10k\Omega$  and  $100k\Omega$  based on DUT impedance

**Comparator:** Primary Nominal

Primary Hi/Lo Limits (Value or %) Secondary Hi/Lo Limits (Value or %)

**Bin Sorting:** Primary Nominal

Primary Hi/Lo Limits (8 Bins in %) Secondary Hi/Lo Limits (Value)

**Results Format:** • Value • Deviation • % Deviation • Bin Number

# **Specifications (Continued)**

**Equivalent Circuit:** Series or Parallel

**Display:** 40 x 4 Character LCD display

**Indication:** Audible alarm programmable HI, LO or OFF for Pass or Fail

**Setup Storage**: 1 Memory Location

**Standard Interfaces:** • RS232

**Optional Interfaces:** • IEEE-488 • Handler

**Connectors:** Front Connection: 4 BNC Sockets (L<sub>CUR</sub>, L<sub>POT</sub>, H<sub>POT</sub>, H<sub>CUR</sub>)

GUARD: Banana Socket

Front Panel Lockout: Key Lock with or without setup recall, Back Lit Display: LOCK

**Mechanical:** Bench Mount

Dimensions:(w x h x d): 12.50 x 4.00 x 8.00 inches

312.5 x 100.0 x 200.0 mm

**Weight:** 10.85 lbs (5 kg) net, 15.2 lbs (7 kg) shipping

**Environmental:** Specifications: 15°C to + 35°C, 75% RH

Operating: 10°C to + 40°C, 10-90% RH Storage: 0°C to + 50°C, 10-90% RH

Pollution Degree 2 Installation Category II

**Power:** • 90-125VAC: 50Hz/60Hz, Consumption: 50VA Max

• 190-250VAC: 50Hz/60Hz, Consumption: 50VA Max

Supplied: • Instruction Manual • AC Power Cable

• 1700-03 Kelvin Clip Lead Set • Calibration Certificate

**Ordering Information:** Description Catalog No.

LCR Digibridge 1715

# Accessories

## **Accessories Included**

Item	Quantity	QuadTech P/N
AC Power Cord	1	4200-0300
Power Line Fuse 630mA 250V SB, 5x20mm	1	520023
Power Line Fuse 315mA 250V SB, 5x20mm	1	520025
Lead Set: 4 BNC Connectors to 2 Kelvin Clips	1	1700-03
Instruction Manual	1	150710
Calibration Certificate	1	N/A

# **Accessories/Options Available**

Item	Quantity	QuadTech P/N
Axial/Radial Component Test Fixture	1	1700-01
Axial/Radial Remote Test Fixture	1	1700-02
Lead Set: 4 BNC Connectors to 2 Kelvin Clips	1	1700-03
Lead Set: 4 BNC Connectors to 4 Banana Plugs	1	1700-04
Lead Set: 4 BNC Connectors to Chip Component Tweezers	1	1700-05
Low Voltage Chip Component Test Fixture	1	7000-07
IEEE-488 (24-pin) & Handler Interface (24-pin)	1	700171
24-pin micro-ribbon plug (for Handler)	1	4220-3024-00

# NOTE:

For proper operation, the  $H_{\text{CUR}}/H_{\text{POT}}/I_{\text{CUR}}/I_{\text{POT}}$  cable shields must be connected together at the DUT. This connection is already made using the 1715 recommended accessory leads. If the shields are not tied together, then at higher frequencies a resonance may occur which could cause erroneous capacitance readings.

# **Safety Precautions**

#### **CAUTION**

Follow these safety instructions at all times.

Failure to comply with these precautions may impair the protection provided by the equipment

1. Operate the 1715 unit with its chassis connected to earth ground. The instrument is shipped with a three-prong power cord to provide this connection to ground. This power cord should only be plugged in to a receptacle that provides earth ground. Serious injury can result if the 1715 unit is not connected to earth ground.

## WARNING

- 1. Dangerous voltages are present in this instrument. Use extreme caution whenever the instrument cover is removed.
- 2. There are no user-serviceable parts inside the instrument. Contact the factory for authorized service.

# **Condensed Operating Instructions**

#### **General Information**

The 1715 Digibridge is an instrument for measuring the passive component primary parameters of inductance (L), capacitance (C), resistance (R) and impedance (Z). Secondary parameters measured are dissipation factor (D), quality factor (Q), reactance (X), phase angle  $\Theta$ ), and resistance (R). Any two of eleven parameters can be measured simultaneously and the results formatted as value, deviation from nominal, percent deviation from nominal or by bin number. Connection to device under test is through 4-BNC terminals on the front panel.

## Start-Up

The 1715 Digibridge unit can be operated from a power source between 90-125V or 190-250V AC at a power line frequency between 48 and 62Hz. Maximum power consumption is 50VA. The standard 1715 unit is shipped from QuadTech with a 630mA fuse in place for AC 90-125V operation. (A 315mA fuse is included for AC 190-250V operation). The 1715 unit is shipped with the line voltage selector set for 115V. Refer to paragraph 1.4.3 for instructions on changing the fuse or line voltage selector.

Connect the 1715 Digibrid ge unit AC power cord to the source of proper voltage. Operate the 1715 instrument with its chassis connected to earth ground. The 1715 instrument is shipped with a three-prong power cord to provide this connection to ground. This power cord should only be plugged into a receptacle that provides earth ground. Serious injury may result if the 1715 instrument is not connected to earth ground.

To turn the 1715 instrument ON, press the power button on the front panel. To switch the power OFF, press the button again or if measurements are to be made proceed with the Test Parameter Setup in Table COI-1. The 1715 instrument should warm up for 15 minutes prior to use.

#### **NOTE**

Please read this instruction manual in its <u>entirety</u> before operating this instrument. These condensed operating instructions are not a substitute for all the information provided in the remainder of this manual.

#### **NOTE**

Refer to paragraphs 2.3 through 2.5 for a <u>full description</u> of programming test parameters and instruction on how to store the test setup. Test parameters must be set <u>before</u> the 1715 instrument can be zeroed.

# **Condensed Operating Instructions (Continued)**

There are three main menus within the 1715 Digibridge instrument software. Familiarize yourself with these menus prior to programming a test. Figure COI-1 illustrates the MEAS DISPLAY screen and lists the functions that can be accessed by pressing the [MAIN INDEX] and [SYSTEM SETUP] keys.

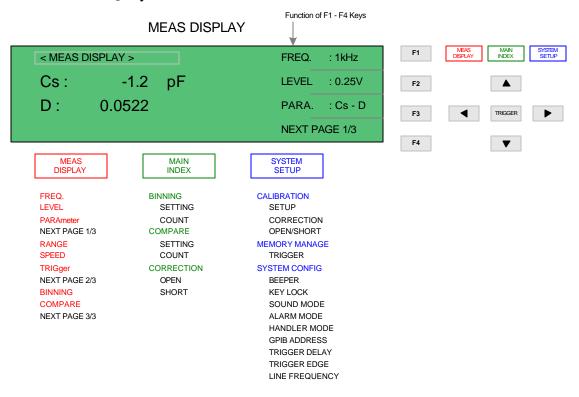


Figure COI-1: 1715 Instrument Menus

#### NOTE:

The function keys [F1 – F4] are used to select the parameter to change and in some menus to change the value of that selected parameter.

The function of UP/DOWN depends on the menu. In some menus, the LEFT/RIGHT keys are used to select a digit by moving the underscored cursor left or right.

# **Condensed Operating Instructions (Continued)**

#### 1. Set Test Parameters

- Press [POWER] ON.
- Allow the instrument to warm up for 15 minutes.
- Press [MEAS DISPLAY]
- Set test parameters (frequency, voltage, parameters) using the function & arrow keys.

## 2. Correction (Zero)

After setting your test parameters, use the correction function of the 1715 Digibridge instrument to zero the test leads. With no device connected, connect the appropriate cable to the front panel BNC connectors. Refer to paragraph 2.6 for cable connections.

With the instrument in MEAS DISPLAY status:

- 1. Press [MAIN INDEX]
- 2. Press [CORRECTION]
- 3. Press [F1] = OPEN (or [F2] = SHORT) to select zero function.
- 4. Press [F2] = MULTI to select frequency.
- 5. Follow instructions on display: i.e.: "Open circuit test leads".
- 6. Press [TRIGGER] button.
- 7. Wait while instrument gets CORRECTION value.
- 8. Press [F4] to exit.
- 9. Repeat steps 3-8 for SHORT correction.

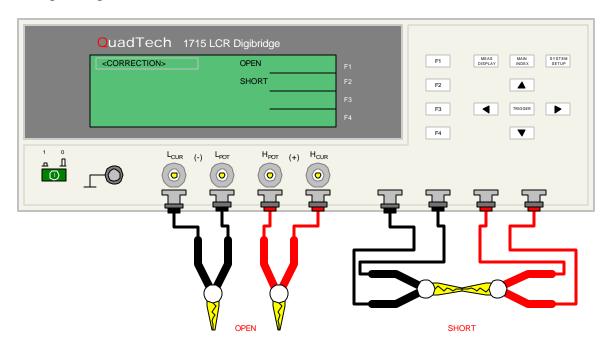
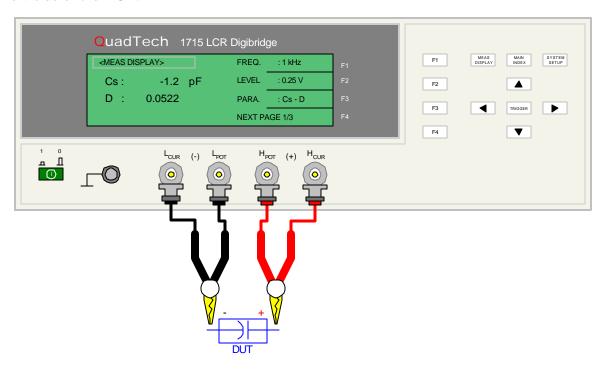


Figure COI-2: Correction OPEN & SHORT Configurations

# **Condensed Operating Instructions (Continued)**

# 3. Connection to Device under Test (DUT)

Figure COI-3 illustrates the connection of the 1715 Digibridge unit to a single DUT using the 1700-03 4-BNC to Kelvin Clips cable lead set. The silver BNC connectors are connected to the front panel BNC terminals on the 1715 unit: red to  $H_{\text{CUR}}/H_{\text{POT}}$  and black to  $I_{\text{CUR}}/L_{\text{POT}}$ . The red Kelvin clip is connected to the high side of the DUT and the black Kelvin clip to the low side of the DUT.



**COI-3: Connection to Device under Test** 

## 4. Make a Measurement

- 1. Press [MEAS DISPLAY]
- 2. Connect device under test (DUT) to test leads.
- 3. Press [TRIGGER].
- 4. Record measurement.

#### NOTE:

For proper operation, the H<sub>CUR</sub>/H<sub>POT</sub>/I<sub>CUR</sub>/I<sub>POT</sub> cable shields must be connected together at the DUT. This connection is already made using the 1715 recommended accessory leads. If the shields are not tied together, then at higher frequencies a resonance may occur which could cause erroneous capacitance readings.

# **Section 1: Introduction**

# 1.1 Unpacking and Inspection

Inspect the shipping carton before opening. If damaged, contact the carrier agent immediately. Inspect the 1715 Digibridge instrument for any damage. If the instrument appears damaged or fails to meet specifications notify QuadTech (refer to instruction manual front cover) or its local representative. Retain the original shipping carton and packing material for future use such as returning the instrument for recalibration or service.

#### 1.2 Product Overview

The 1715 Digibridge instrument is a compact yet powerful LCR meter for production or laboratory testing of inductors, capacitors, resistors and other passive components. The 1715 instrument measures 11 parameters: Ls, Lp, Cs, Cp, Rs, Rp, D, Q, |Z|, Xs and  $\theta$  and displays two simultaneously. Basic accuracy is  $\pm 0.2\%$  for LCR and  $\pm 0.002$  for DQ measurements. Automatic or Hold Range can be selected. Measurement rate is also selectable (Slow, Medium or Fast) with rates up to 25 measurements per second. Measurements can be made continuously or triggered with a programmable delay time to 9999milliseconds. The RS232 interface is standard and the IEEE-488/Handler interface is optional equipment on the 1715 instrument. Zero the effects of stray admittance/residual impedance in the test leads with the open/short correction function. The 1715 unit automatically selects the instrument source impedance as  $25\Omega$ ,  $100\Omega$ ,  $1k\Omega$ ,  $10k\Omega$  or  $100k\Omega$  based on the impedance of the device under test. Four test frequencies are selectable: 100Hz, 120Hz, 1kHz and 10kHz (9.6kHz). The 1715 instrument is equipped with 8 Pass/Fail bins. Test results can be formatted as nominal value, deviation from nominal value or %deviation from nominal value. Bin number or Pass/Fail can be displayed as well. Connection to the device under test is through 4 BNC terminals on the front panel.

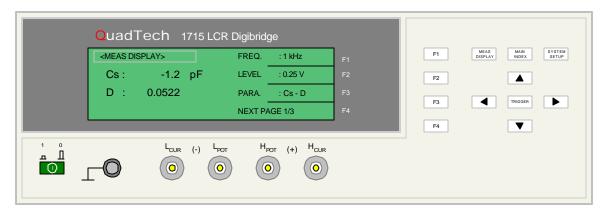


Figure 1-1: 1715 LCR Digibridge

Introduction Page 17 of 87

# 1.3 Controls and Indicators

## 1.3.1 Front Panel Controls and Indicators

Figure 1-2 illustrates the controls and indicators on the front panel of the 1715 Digibridge instrument. Table 1-1 identifies them with description and function.

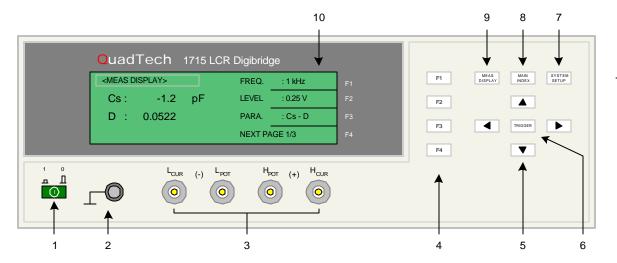


Figure 1-2: 1715 Front Panel Controls & Indicators

**Table 1-1: 1715 Front Panel Controls & Indicators** 

Reference # Figure 1-2	Name	Type	Function	
1		Green Push Button	Apply AC POWER: 1=ON, 0=OFF	
2		Silver Banana Jack	Chassis ground connection	
3	$L_{CUR}$	4 silver BNC	Current Drive Terminal, Low (-)	
	$L_{POT}$	terminals	Voltage Sense Terminal, Low (-)	
	$H_{POT}$		Voltage Sense Terminal, High (+)	
	$H_{CUR}$		Current Drive Terminal, High (+)	
4	F1, F2, F3	4 gray push buttons	Select Instrument Functions	
	and F4		Keys perform different functions under different menus.	
			Right side of display shows corresponding key function.	
5	? ,? ,? ,?	4 gray push buttons	Move backlit box around display to choose parameter	
			Change parameter value (increase/decrease)	
6	TRIGGER	Gray push button	Initiate measurement	
7	SYSTEM	Gray push button	View, Select or Change System Parameters:	
	SETUP		Calibration, Memory Manage & System Config (Beeper,	
			Key Lock, Sound, Alarm, Handler, GPIB Address,	
			Trigger Delay, Trigger Edge & Line Frequency)	
8	MAIN	Gray push button	View, Select or Change Setup & Result Parameters:	
	INDEX		Binning, Compare, & Correction	
9	MEAS	Gray push button	View, Select or Change Measurement Parameters:	
	DISPLAY		Frequency, Voltage, Parameter (Pri/Sec), Range, Speed,	
			Trigger, Binning and Compare	
10		40 x 4 Character	Show measurement results as value, deviation,	
		LCD display	%deviation or bin number.	
			Show programming instructions	

Page 18 of 87 Introduction

# 1.3.2 Rear Panel Controls and Connectors

Figure 1-3 illustrates the controls and connectors on the rear panel of the 1715 Digibridge instrument. Table 1-2 identifies them with description and function.

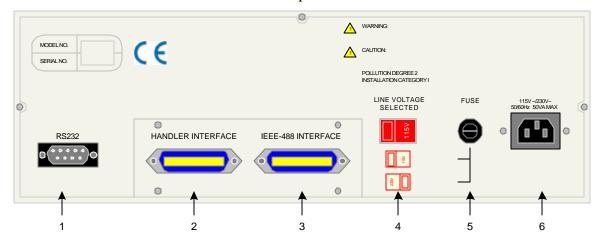


Figure 1-3: Rear Panel 1715 Instrument

**Table 1-2: 1715 Rear Panel Controls & Connectors** 

Reference #	Name	Туре	Function
Figure 1-3			
1	RS 232	Silver /Black	RS 232 interface for remote operation
	INTERFACE	9-pin connector	
2	HANDLER	Blue	Handler Interface connector for remote operation
	INTERFACE	24-pin connector	
3	IEEE-488	Blue	IEEE-488 Interface connector for data transfer
	INTERFACE	24-pin connector	
4	LINE VOLTAGE	2 Red 2-position	Select Voltage Level corresponding to AC Source
	SELECTED	Slide Switches	90V – 125V: T630mA 250V fuse
			190V – 250V: T 315mA 250V fuse
5	FUSE	Black	Short circuit protection
		Screw cap fuse holder	T 630mA 250V fuse for 115V operation
			T 315mA 250V fuse for 230V operation
6	AC Line Input	Black	Connection to AC power source
		3-wire inlet module	

Introduction Page 19 of 87

#### 1.4 Installation

#### 1.4.1 Dimensions

The 1715 Digibridge unit is supplied in a bench configuration, i.e., in a cabinet with resilient feet for placement on a table. The 1715 instrument can be tilted up for convenient operator viewing by extending the front feet out.

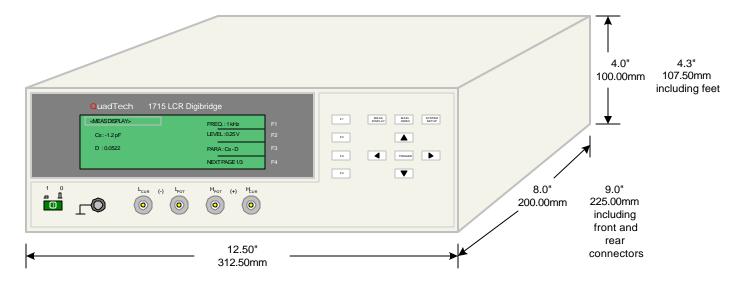


Figure 1-4: 1730 Instrument Dimensions

#### 1.4.2 Instrument Positioning

The 1715 instrument contains one (1) LCD display for direct readout of measured parameters. The optimum angle for viewing is slightly down and about 10 degrees either side of center. For bench operation the front flip feet should always be used to angle the instrument up. In bench or rack mount applications the instrument should be positioned with consideration for ample air flow around the rear panel fan ventilation hole. An open space of at least 3 inches (75mm) is recommended behind the rear panel. Testing should be performed on a non-conductive surface. An ESD mat is not a recommended test platform.

#### 1.4.3 Power Requirements

The 1715 can be operated from a power source of 90 to 125V AC or 190 to 250V AC. Power connection is via the rear panel through a standard receptacle. Before connecting the 3-wire power cord between the unit and AC power source, make sure the voltage selection switches on the rear panel (Figure 1-5) are in accordance with the power source being used. For a 90-125V source, use a 630mA 250V fuse. For a 190-250V source, use a 315mA 250V fuse. Always use an outlet that has a properly connected protection ground.

Page 20 of 87 Introduction

#### **CAUTION**

Make sure the unit has been disconnected from its AC power source for at least five minutes before proceeding.

### **Procedure For Changing A 1715 Instrument Fuse**

Unscrew the fuse cap on the rear panel of the 1715 and pull fuse holder outward.

Once the fuse holder has been removed from the instrument snap the fuse from the holder and replace. Make sure the new fuse is of the proper rating.

Install the fuse back into the cap holder by pushing in until it locks securely in place.

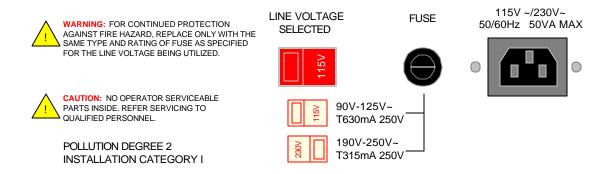


Figure 1-5: Close-Up of 1715 Rear Panel

## **1.4.4** Safety Inspection

Before operating the instrument inspect the fuse holder on the rear of the 1715 instrument to ensure that the properly rated fuse is in place, otherwise damage to the unit is possible. Make sure that the voltage selector switches are set in accordance with the power source in use. Refer to paragraph 1.4.3 and Figure 1-5.

The 1715 instrument is shipped with a standard U.S. power cord, QuadTech P/N 4200-0300 (with Belden SPH-386 socket or equivalent, and a 3-wire plug conforming to IEC 320). Make sure the instrument is only used with these cables (or other approved international cord set) to ensure that the instrument is provided with connection to protective earth ground.

The surrounding environment should be free from excessive dust to prevent contamination of electronic circuits. The surrounding environment should also be free from excessive vibration. Do not expose the 1715 instrument to direct sunlight, extreme temperature or humidity variations, or corrosive chemicals.

Introduction Page 21 of 87

# **Section 2: Operation**

#### 2.1 Terms and Conventions

**Table 2-1: Measurement Unit Prefixes** 

<u>Multiple</u>	<u>Scientific</u>	<b>Engineering</b>	Symbol
1000000000000000	1015	Peta	P
1000000000000	1012	Tera	T
1000000000	10 <sup>9</sup>	Giga	G
1000000	106	Mega	M
1000	10 <sup>3</sup>	Kilo	k
.001	10-3	milli	m
.000001	10-6	micro	μ
.000000001	10 <sup>-9</sup>	nano	n
.000000000001	10-12	pico	p
.000000000000001	10-15	femto	f

Accuracy:

The difference between the measured value or reading and the true or accepted value. The accuracy of an LCR meter is typically given as a  $\pm$  percentage of the measured value for primary parameters and  $\pm$  an absolute value for secondary value. For example:  $\pm 0.05\%$  for L, C & R and  $\pm 0.0005$  for Df.

Basic Accuracy:

Basic accuracy is specified at optimum test signal, frequencies, highest accuracy setting or slowest measurement speed and impedance of the DUT. As a general rule this means 1VAC RMS signal level, 1kHz frequency, high accuracy which equates to 1 measurement/second, and a DUT impedance between  $10\Omega$  and  $100k\Omega$ .

Binning:

Procedure for sorting components into bins using sequential limits or nested limits.

Capacitor:

Abbreviated C (as in LCR). A capacitor is passive component comprised of two conductors separated by a dielectric. A capacitor stores charge blocks DC flow and allows AC flow based on frequency and capacitor design.

Operation Page 23 of 87

Capacitance: The measure of the ratio of charge on either plate of a capacitor to

the potential difference (voltage) across the plates. Unit of measure

is the Farad (F).

Capacitive Reactance: A measurement of the actual AC resistance of a capacitor. How

effective a capacitor allows AC to flow depends upon its

capacitance and the frequency used.  $X_C = 1 / 2\pi fC$ .

Compare: Procedure for sorting components by comparing the measured

value against a known standard.

**Current:** 

AC: Alternating Current. AC is an electrical current that has one

polarity during part of the cycle and the opposing polarity during

the other part of the cycle. Residential electricity is AC.

DC: Direct Current. Non-reversing polarity. The movement of charge

is in one direction. Used to describe both current and voltage.

Batteries supply direct current (DC).

Dielectric: A material which is an electrical insulator or in which an electric

field can be sustained with a minimum dissipation of power.

Dielectric Constant: Abbreviated K, relative dielectric constant. The dielectric constant

of a material is the ratio of the capacitance of a capacitor filled with a given dielectric to that same capacitor having only a

vacuum as a dielectric.

Discharge: The act of draining off an electrical charge to ground. Devices that

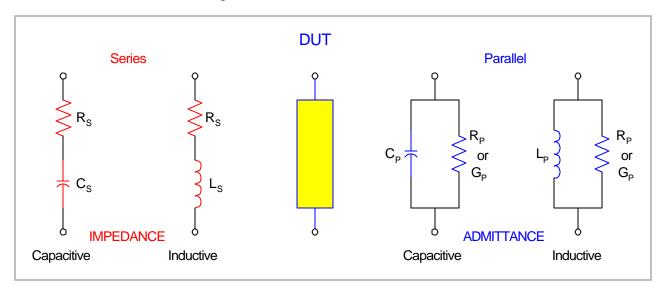
retain charge should be discharged after an IR test or DC hipot test.

DUT: Device Under Test. (i.e. the product being tested).

Page 24 of 87 Operation

Equivalent Circuit:

The configuration of the device under test. Is it a series or parallel equivalent circuit?



Frequency: The rate at which current or voltage reverses polarity and then

back again completing a full cycle, measured in Hertz (Hz) or

cycles/second. AC Line Frequency = 50/60 Hz.

Ground: The base reference from which voltages are measured, nominally

the same potential as the earth. Ground is also the side of a circuit

that is at the same potential as the base reference.

Impedance: The AC resistance of the DUT. Impedance (Z) is a vector

summation of resistance R and reactance X.

For capacitors reactance is defined as  $XC = 1/j\omega C$ For inductors reactance is defined as  $XL = i\omega L$ 

For resistors resistance is defined as R Impedance is defined as  $Z = \sqrt{(X2 + R2)}$ 

Inductor: Abbreviated L (as in LCR). An inductor is a coil of wire. It is used

to create electromagnetic induction in a circuit.

Inductance: The property of a coil to oppose any change in current through it.

If the turns (coils) of the wire are stretched out, the field intensity will be less and the inductance will be less. Unit of measure is the

Henry (H).

Inductive Reactance: A measure of how much the counter electro-magnetic force (emf)

of the coil will oppose current variation through the coil. The amount of reactance is directly proportional to the current

variation:  $X_L = 2\pi f L$ .

Operation Page 25 of 87

**Interface:** 

Handler: Device for remote control of test instrument in component

handling operations.

IEEE-488: General Purpose Interface Bus (GPIB). GPIB is an industry

standard definition of a Parallel bus connection for the purpose of

communicating data between devices.

RS232: An industry standard definition for a Serial line communication

link or port.

Scanner: An electronic device designed to switch or matrix signals.

Level: The test signal level is the programmed RMS voltage of the

generator in an LCR meter. The actual test voltage across the DUT is always less than the programmed level. Refer to VM/IM

feature to view actual signal across DUT.

**Limits:** 

High Limit: The high limit is the upper value for a test to be considered a pass.

If the measured value is higher than the high limit the test is

considered a fail.

Low Limit: The low limit is the lower value for a test to be considered a pass.

If the measured value is lower than the low limit the test is

considered a fail.

Parameter: Electrical property being tested. The primary parameter (L, C, R)

is the first property characterized of the device under test. The secondary parameter  $(D, Q, \theta)$  is the second property characterized

of the device under test.

Permittivity: Abbreviated  $\varepsilon$ . The dielectric constant multiplied by the dielectric

constant of empty space  $(\epsilon_0)$ , where the permittivity of empty space  $(\epsilon_0)$  is a constant in Coulomb's Law, equal to a value of 1 in centimeter-gram-second units and to  $8.854 \times 10^{-12}$  farads/meter in

rationalized meter-kilogram-second units.

Range: The resistance ranges the instrument uses for reference in making

the measurement.

Page 26 of 87 Operation

Repeatability: The difference between successive measurements with no changes

in the test setup or test conditions.

Reproducibility: Similar to repeatability but adds the element of what could be

expected under real life conditions. Reproducibility would take into account the variability in thing like fixturing where the DUT being tested is removed from the fixture and then inserted again.

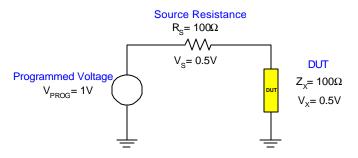
Resolution: The smallest value that can be shown on the display in a digital

instrument. LCR meters typically specify a measurement range that is the largest and smallest value that can be shown on the

display.

Source Impedance: A constant source resistance of the measuring instrument used to

level the voltage across the DUT to a constant voltage.



Speed: The rate at which the instrument makes a measurement in

measurements per second. Speed is inversely proportional to

accuracy.

**Trigger:** The device for initiating the test (applying the voltage or current).

External: The test is initiated via an external source such as a computer with

an IEEE-488 or Handler interface. One measurement is made each

time the external trigger is asserted on the handler.

Internal: The instrument continuously makes measurements.

Manual: The operator initiates the test by pressing the [START] button.

One measurement is made each time the trigger is pressed.

Operation Page 27 of 87

# 2.2 Startup

Check to make sure the red Line Voltage Selector switch on the rear panel agrees with the power source available. Depending on the power source the switch position should be in the up or down position as shown in Figure 1-5 (Close-Up of 1715 Rear Panel).

Connect the instrument power cord to the source of proper voltage. The instrument is to be used only with three-wire grounded outlets.

Power is applied to the 1715 instrument by pressing the green power switch on the front panel to the ON (1 position). The 1715 unit should warm up for a period of at least 15 minutes prior to measurements being made.

#### 2.3 SYSTEM SETUP

The SYSTEM SETUP menu contains three functions: Calibration, Memory Management and System Configuration. Press the [SYSTEM SETUP] button to access these functions.

#### 2.3.1 Calibration

For QuadTech service personnel only. Calibration of the 1715 instrument is required during initial manufacture only. Verification is recommended on an annual basis.

### 2.3.2 Memory Management

For QuadTech service personnel only.

## 2.3.3 System Configuration

Prior to programming a test or measuring a device, set up the system controls of the 1715 instrument. To access the system controls, press [SYSTEM SETUP] then press [SYSTEM CONFIG]. Table 2-2 lists the contents of SYSTEM CONFIG.

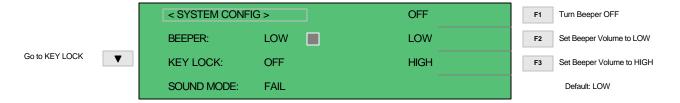
**Table 2-2: SYSTEM CONFIG** 

Parameter	Function	Range
BEEPER	Set beeper loudness	OFF, LOW or HIGH
KEY LOCK	Lock out front panel programming	OFF/ON
SOUND MODE	Set when the buzzer will sound	PASS/FAIL
ALARM MODE	Set type of alarm signal	PULSE/CONTINUOUS
HANDLER MODE	Set handler interface mode	CLEAR/HOLD
GPIB ADDRESS	Set interface address	00 - 30
TRIGGER DELAY	Set external trigger time	0000 – 9999 ms
TRIGGER EDGE	Set trigger mode	FALLING/RISING
LINE FREQUENCY	Set power line frequency	50Hz/60Hz
BAUD RATE	Set baud rate	2400/4800/9600/19200/38400

Page 28 of 87 Operation

#### **2.3.3.1 BEEPER**

The loudness of the beeper or audible alarm can be set to OFF, LOW or HIGH. The instrument default setting is LOW. To change the beeper loudness press [SYSTEM SETUP], [SYSTEM CONFIG] and the down arrow  $[\ \downarrow\ ]$  until the box next to BEEPER is highlighted, then press [F1] = OFF, [F2] = LOW or [F3] = HIGH.



#### **2.3.3.2 KEY LOCK**

To lock out the front panel operations with the exception of the [TRIGGER] key, set the key lock function to ON. Press [SYSTEM SETUP], [SYSTEM CONFIG], [↓] until OFF is highlighted next to KEY LOCK, then press [F1] = ON. The backlit LOCK block will appear on the measure display. To turn the key lock function OFF: press [F1], [F4] and then [SYSTEM SETUP]. Key lock can be set ON or OFF. The instrument default setting is OFF.



#### **2.3.3.3 SOUND Mode**

The audible alarm can be set to sound on PASS or to sound on FAIL under high or low limit judgment in the measure display. The instrument default setting is FAIL. To change the sound mode press [SYSTEM SETUP], [SYSTEM CONFIG] and the down arrow  $[\ \downarrow\ ]$  until the box next to SOUND MODE is highlighted, then press [F1] = PASS for the alarm to sound on a pass result or [F2] = FAIL for the alarm to sound on a fail result.



Operation Page 29 of 87

#### **2.3.3.4 ALARM Mode**

The type of audible alarm can be set to PULSE or CONTINUOUS during judgment in the measure display. The instrument default setting is PULSE. To change the alarm mode press [SYSTEM SETUP], [SYSTEM CONFIG] and the down arrow  $[\ \downarrow\ ]$  until the box next to ALARM MODE is highlighted, then press [F1] = PULSE for the alarm to sound in a pulse tone or [F2] = CONTINUOUS for the alarm to sound continuously.



#### 2.3.3.5 HANDLER Mode

The handler interface mode can be set to CLEAR or HOLD. The instrument default setting is CLEAR. When set to CLEAR, the handler interface will clear the last test result prior to each subsequent measurement. When set to HOLD, the handler interface will hold the last test result until the next measurement is made and displayed. To change the handler mode press [SYSTEM SETUP], [SYSTEM CONFIG] and the down arrow [↓] until the box next to HANDLER MODE is highlighted, then press [F1] = CLEAR or [F2] = HOLD.



#### 2.3.3.6 GPIB Address Code

The IEEE-488 interface address can be programmed from 00 to 30. The instrument default setting is 17. To change the GPIB ADDRESS press [SYSTEM SETUP], [SYSTEM CONFIG] and the down arrow  $[\downarrow]$  until the box next to GPIB ADDRESS is highlighted, then press [F1] = DIGIT UP to increase the address, or [F2] = DIGIT DOWN to decrease the address.



Page 30 of 87 Operation

#### 2.3.3.7 TRIGGER Delay

The trigger delay is the amount of time between the activation of a trigger (via IEEE, Handler or front panel) and the 1715 making the measurement. The delay time can be programmed from 0000 to 9999 milliseconds. The instrument default value is 0000 milliseconds. To change the TRIGGER DELAY press [SYSTEM SETUP], [SYSTEM CONFIG] and the down arrow [4] until the box next to TRIGGER DELAY is highlighted, then press [F1] = DIGIT UP to increase the delay time, [F2] = DIGIT DOWN to decrease the delay time or [F3] = DIGIT to move over a decimal place.



## 2.3.3.8 TRIGGER Edge

Select on which edge the measurement is triggered: FALLING or RISING. The instrument default setting is FALLING. To change the TRIGGER EDGE press [SYSTEM SETUP], [SYSTEM CONFIG] and the down arrow  $[\mbox{$\downarrow$}]$  until the box next to TRIGGER EDGE is highlighted, then press [F1] = FALLING or [F2] = RISING.



#### 2.3.3.9 Line Frequency

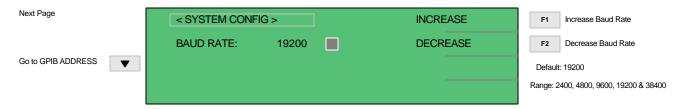
Select the power line frequency: 50Hz or 60Hz. The instrument default setting is 60Hz. To change the LINE FREQUENCY press [SYSTEM SETUP], [SYSTEM CONFIG] and the down arrow  $[\ \ \ ]$  until the box next to LINE FREQUENCY is highlighted, then press [F1] = 50Hz or [F2] = 60Hz.



Operation Page 31 of 87

#### 2.3.3.10 Baud Rate

The baud rate is the amount of bits per second transferred via the RS232 interface. The baud rate can be programmed as: 2400, 4800, 9600, 19200 or 38400 bps. The instrument default value is 19200 bps. To change the BAUD RATE press [SYSTEM SETUP], [SYSTEM CONFIG] and the down arrow  $[\Downarrow]$  until the box next to BAUD RATE is highlighted, then press [F1] = INCREASE to increase the baud rate or [F2] = DECREASE to decrease the baud rate.



Page 32 of 87 Operation

# 2.4 MEAS DISPLAY

The 1715 instrument's stand-by display is the MEAS DISPLAY. After power has been applied to the instrument and it cycles quickly through the information screen, the instrument reverts to the MEAS DISPLAY. To view the instrument information screen as illustrated in Figure 2.1, press [SYSTEM SETUP] then [←].

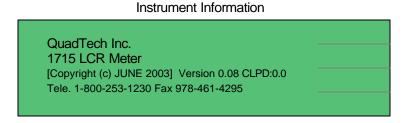


Figure 2.1: Instrument Information Screen

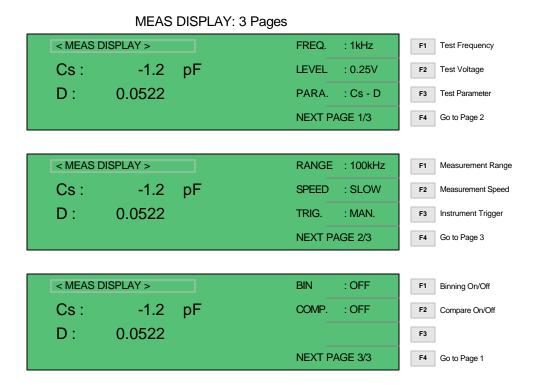


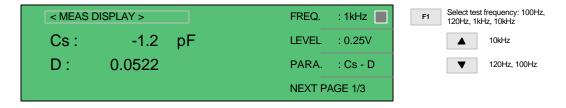
Figure 2.2: MEAS DISPLAY

Figure 2.2 illustrates the three pages of parameters that can be programmed within the MEAS DISPLAY. The binning and comparison functions are enabled/disabled in MEAS DISPLAY and programmed in MAIN INDEX Paragraphs 2.4.1 through 2.4.9 explain each parameter in detail.

Operation Page 33 of 87

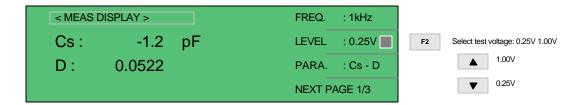
#### 2.4.1 FREQuency

The 1715 instrument provides four test frequencies in the 100Hz to 10kHz range including 100Hz, 120Hz, 1kHz and 10kHz (9.6kHz). In MEAS DISPLAY, press [F1] so that the highlighted cursor is to the right of 1.0 kHz. Use the up arrow [↑] key to increase the frequency value or use the down arrow [↓] key to decrease the frequency value. The instrument default setting is 1.0kHz.



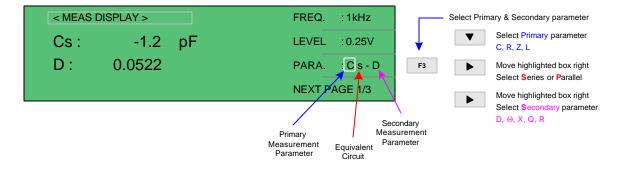
#### **2.4.2 LEVEL**

The test voltage can be selected as: 0.25V or 1.00V RMS. In MEAS DISPLAY press [F2] so that the 1.00 V box is highlighted. Use the up arrow [ $\uparrow$ ] key to increase the voltage value or use the down arrow  $\downarrow$ ] key to decrease the voltage value in 10mV increments. The instrument default setting is 1.00V.



#### 2.4.3 PARAmeter

The 1715 instrument can measure 11 different LCR parameters and display two (primary and secondary) simultaneously. In MEAS DISPLAY press [F3] so that the  $\boxed{C}$  sD box is highlighted. Use the down arrow  $[\Downarrow]$  key to change/select the primary parameter. Use the right arrow  $[\Longrightarrow]$  key to move the highlighted box to  $\boxed{S}$  and use the  $[\Uparrow]$  key to select the equivalent circuit equal to series or parallel. Use the right arrow  $[\Longrightarrow]$  key to move the highlighted box to  $\boxed{D}$  and use the down arrow  $[\Downarrow]$  key to select the secondary parameter. The instrument default setting is CsD.



Page 34 of 87 Operation

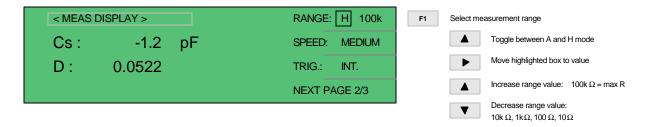
The programming of parameter may at first seem a little confusing but remember the highlighted box is what is selected then pressing the down arrow  $[\ \ ]$  key will toggle through the choices. Use the right arrow  $[\ \ ]$  key to move the highlighted box and select the next parameter then press the down arrow  $[\ \ ]$  key to toggle through the choices. Table 2-3 lists the primary and secondary parameters in common pair configuration that are measurable by the 1715 instrument.

**Table 2-3: 1715 Measurement Parameters** 

	Primary	Secondary		
Cs	Capacitance	$D/Rs/\theta/Xs/Q$	Dissipation Factor	
Ср	Capacitance	D/Rp/Q	Dissipation Factor	
Rs	Resistance	Xs/Q/D/Rs/θ	Series Reactance	
Rp	Resistance	Q	Quality Factor	
Zs	Impedance	θ/Xs/Q/D/Rs	Phase Angle	
Ls	Inductance	Q/Rs/D/θ/Xs	Quality Factor	
Lp	Inductance	Q/Rp/D	Quality Factor	

#### **2.4.4 RANGE**

The 1715 instrument's measurement range can be selected as AUTO or HOLD. The five instrument measurement ranges are  $100k\Omega$ ,  $10k\Omega$ ,  $10k\Omega$ ,  $100\Omega$  and  $10\Omega$  depending on the test frequency and selected constant source impedance. In MEAS DISPLAY (Pg 2/3) press [F1] so that the  $\boxed{A}$  box is highlighted\*. Use the up arrow  $\boxed{1}$  key to increase the range value or use the down arrow  $\boxed{1}$  key to decrease the range value. The instrument default setting is A (Auto Range).



<sup>\*</sup> Use the up arrow  $[\uparrow]$  key to toggle between A (Auto) and H (Hold). Use the right arrow  $[\Rightarrow]$  key to move the range value.

Operation Page 35 of 87

#### 2.4.5 **SPEED**

Trading accuracy for speed, program the measurement speed of the 1715 instrument to Slow (2measurements/second), Medium (8 measurements/second) or Fast (25 measurements/second). The basic LCR accuracy (0.2%) and D accuracy (0.002) are specified for the slow measurement speed. In MEAS DISPLAY (Pg 2/3), press [F2] so that the highlighted cursor is to the right of MEDIUM. Use the up arrow [1] key to increase the speed or use the down arrow [1] key to decrease the speed. The instrument default setting is MEDIUM (8 meas/second).



The accuracy of the 1715 instrument depends on the speed of the measurement. Basic Accuracy for LCR is  $\pm 0.2\%$  and basic accuracy for DQ is  $\pm 0.002$ . Basic accuracy is specified for the speed equal to 2 measurements/second, temperature =  $23^{\circ}$ C  $\pm 5^{\circ}$ C, relative humidity (RH)  $\leq 90\%$ .

Table 2-4 lists the basic accuracy for |Z| -  $\theta$ . For measurements made in fast mode double the accuracy listed in Table 2-4.

 $10M\Omega$ 2.5% 1.0% 0.8% 0.6° 0.5° 0.4° 1ΜΩ 0.6% 0.5% 0.4% 0.9%  $0.4^{\circ}$ 0.3°  $0.25^{\circ}$ 1.9° 100kΩ 0.4% 0.3% 0.2% 0.6% 0.20 0.15° 0.12° 0.80 10kΩ **Impedance** 0.2% 0.10 **Z** (Ω) 100Ω 0.3% 0.25% 0.2% 0.2% 0.1°  $0.15^{\circ}$  $0.12^{\circ}$  $0.12^{\circ}$ 10Q 0.4% 0.3% 0.25% 0.3% 0.2° 0.2°  $0.15^{\circ}$  $0.2^{\circ}$ 1Ω 1.0% 0.8% 0.8% 1.2%  $0.8^{\circ}$  $0.8^{\circ}$  $0.8^{\circ}$ 1.00  $0.1\Omega$ 100Hz 120Hz 1kHz 10kHz Frequency

(Hz)

**Table 2-4: 1/2 Z1/2 - q Accuracy** 

Page 36 of 87 Operation

# **More 1715 Accuracy Formulas**

## L, C & R Accuracy

For 
$$Q \ge 10$$
 and  $(D \le 1)$ ,  $|Z| =$  
$$|Z_L| = |2\pi fL|$$
 
$$|Z_C| = |1/(2\pi fC)|$$
 For  $Q < 10$  and  $(D > 1)$ , 
$$Multiply L accuracy by [1 + (1/Q)]$$
 
$$Multiply C accuracy by (1 + D)$$

# D & Q Accuracy

For all D values:

DF Accuracy = 
$$\left[ \frac{|Z| \ \text{Accuracy (\%)}}{100} + \frac{DF}{50} \right] \times \left[ 1 + \sqrt{\frac{FREQ}{50000}} \right]$$

For all values of Q:

$$Q_{ACCURACY} = \left[ \frac{Accuracy \%}{100} \right] + \left[ |Q| \left[ 0.02 + \frac{Accuracy \%}{100} \right] \right] + \left[ Q^2 \left[ \frac{Accuracy \%}{100} \right] \right]$$

# R Accuracy

For 
$$Q \le 0.1$$
:  
Accuracy of  $R = Accuracy of |Z|$ 

For 
$$Q \ge 0.1$$
:  
Multiply accuracy R by  $(1 + Q)$ 

Figure 2-3 illustrates the frequency conversion charts for LC to Z, C to Z and L to Z.

Operation Page 37 of 87

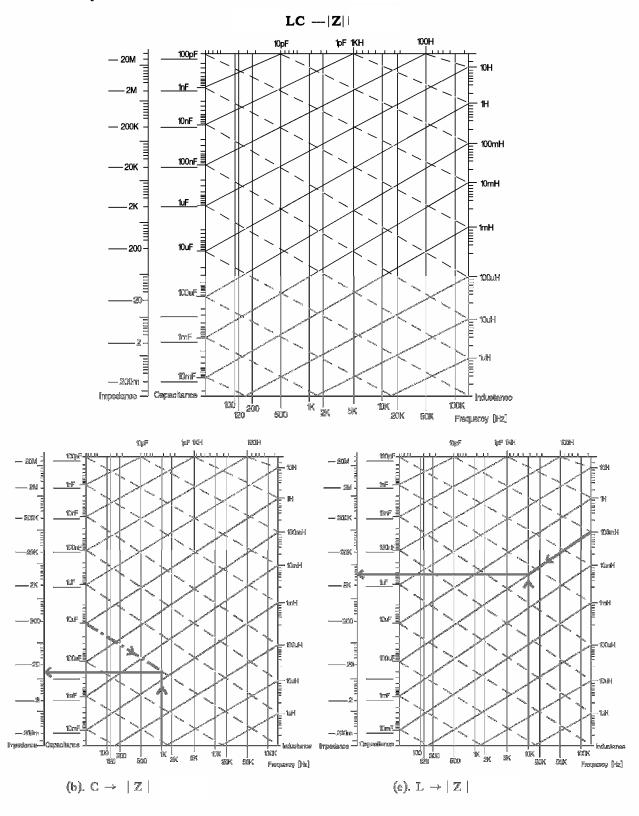
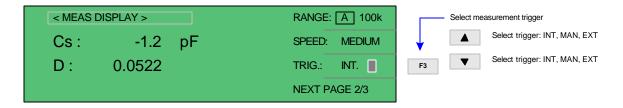


Figure 2-3: 1715 Accuracy Formula Conversion Charts

Page 38 of 87 Operation

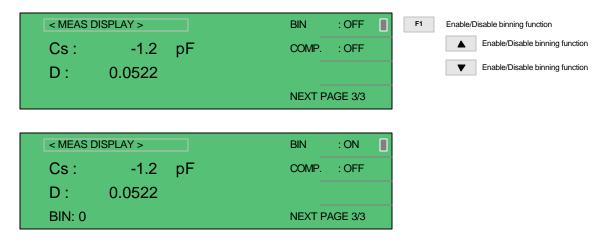
# 2.4.6 TRIGger

The 1715 instrument can be triggered manually, internally or externally. In MEAS DISPLAY (Pg 2/3), press [F3] so that the highlighted cursor is to the right of INT. Use the up arrow [↑] key to change the trigger or use the down arrow [↓] key to change the trigger. The instrument default setting is INT (internal trigger). When MANUAL trigger is selected, one measurement will be made each time the trigger is pressed. When EXTERNAL trigger is selected, one measurement will be made each time the external trigger is asserted by the handler. When INTERNAL trigger is selected, measurements are performed continuously when in [MEAS DISPLAY].



#### **2.4.7 BINNING**

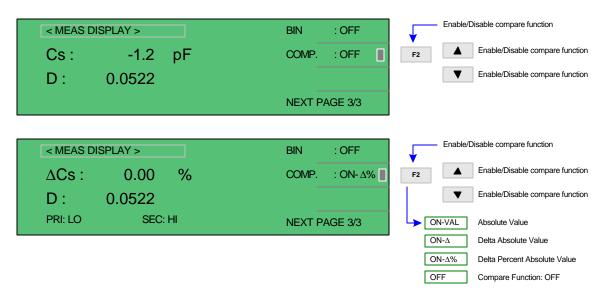
The 1715 instrument has 8 pass/fail bins for sorting components by test result. To enable/disable the binning function, in MEAS DISPLAY (Pg 3/3) press [F2] so that the highlighted cursor is to the right of OFF. Use the up arrow [↑] key or down arrow [↓] key to switch the binning function ON/OFF. The instrument default setting is OFF. Setting the bin values is done within the MAIN INDEX menu. Refer to paragraph 2.5.1 for instructions on setup of Binning.



Operation Page 39 of 87

#### **2.4.8 COMPARE**

The 1715 instrument has 8 pass/fail bins for sorting components by test result. To enable/disable the compare function, in MEAS DISPLAY (Pg 3/3), press [F3] so that the highlighted cursor is to the right of OFF. Use the up arrow [h] key or down arrow [h] key to switch the compare function ON/OFF\*. The instrument default setting is OFF. Setting the comparison values is done within the MAIN INDEX menu. Refer to paragraph 2.5.4 for instructions on setup of Compare.



<sup>\*</sup> Refer to "Notes on Compare Settings".

#### **Notes on Compare Settings:**

Setting COMPARE = ON-VAL will display the primary and secondary readings in addition to a GO (PASS). A LO reading is bwer than the set nominal value and a HI reading is higher than the set nominal value.

Setting COMPARE =  $ON-\Delta$  will display the difference between the measured value and the set nominal value. A OO, OO, OO, OO will judgment is also displayed.

Setting COMPARE =  $\boxed{ON-\Delta\%}$  will display the percent difference between the measured value and the set nominal value. A  $\boxed{GO}$ ,  $\boxed{LO}$ , or  $\boxed{HI}$  judgment is also displayed.

Page 40 of 87 Operation

#### 2.5 MAIN INDEX

Within the 1715 instrument's MAIN INDEX are the Binning, Compare and Correction functions. To access these functions press [MAIN INDEX] and the display should look as shown in Figure 2-4.

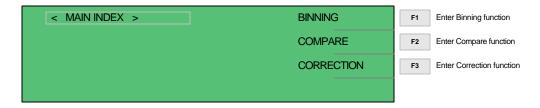
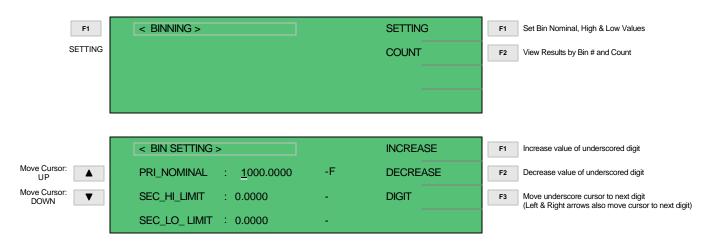


Figure 2-4: MAIN INDEX

#### **2.5.1 BINNING**

To set the bin functions for the 1715 instrument, press [MAIN INDEX] then [F1] = BINNING.



- Press [F1] = BIN SET and to enter the BIN SET Display and set the nominal, high and low values for the primary parameter.
- To select the nominal, high or low value, move the underscore cursor UP using the up arrow  $[\uparrow]$  or to move it down using the down arrow  $[\downarrow]$ .
- Press [F1] = INCREASE to increase the value of the underscored digit.
- Press [F2] = DECREASE to decrease the value of the underscored digit.
- Press [F3] = DIGIT to move the underscored digit right. The left [←] and right [⇒] arrow keys also move the underscored digit left or right on a single line.
- The units of the values can be selected using the INCREASE and DECREASE when the underscore cursor is in the right most position.

When the nominal, secondary high and secondary low values are set, use the down [ $\downarrow$ ] arrow key to move the underscore cursor SEC\_LO\_LIMIT:  $\underline{0}.0000$  down to view the high and low percent settings for bins 1-8.

Operation Page 41 of 87

## **BIN Set and BIN Count**

After setting the SEC\_LO\_LIMIT:  $\underline{0}.0000$  value, press the down [ $\downarrow$ ] arrow key to view bins 1-3.

Press the down  $[\mbox{$\downarrow$}]$  arrow key again to view bins 4-6.

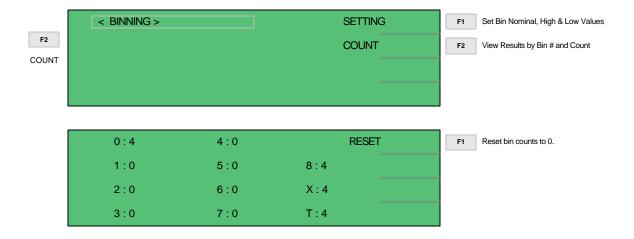
Press the down  $[\downarrow]$  arrow key again to view bins 7-8.

Press the [MAIN INDEX] key to return to the MAIN INDEX BINNING screen.

Press the [F2] = COUNT to view the bin count for bins 1-8 and the OUT bin.

#### In the BIN COUNT screen:

Press [F1] = RESET to clear the contents of the bins. Press [MAIN INDEX] when finished.



Page 42 of 87 Operation

Two of the most common methods of sorting results into bins are using nested limits or sequential limits.

#### **Nested Limits**

Nested limits are a natural choice for sorting components by % tolerance around a single nominal value with the lower bins narrower than the higher numbered bins. Nested limits for three bins are illustrated in Figure 2-5. Note that the limits do not have to by symmetrical (Bin 3 is -7% and +10%).

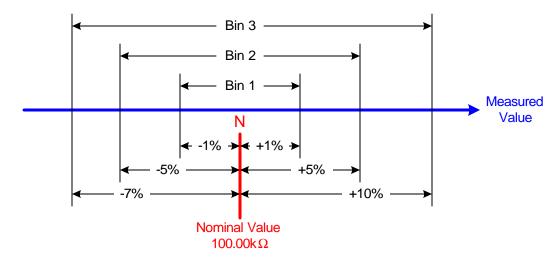


Figure 2-5: Nested Limits

## **Sequential Limits**

Sequential limits are a natural choice when sorting components by absolute value. Figure 2-6 illustrates the use of sequential limits for a total of three bins. Sequential bins do not have to be adjacent. Their limits can overlap or have gaps depending upon the specified limit. Any component that falls into an overlap between bins would be assigned to the lower numbered bin and any component that falls into a gap between bins would be assigned to the overall fail bin.

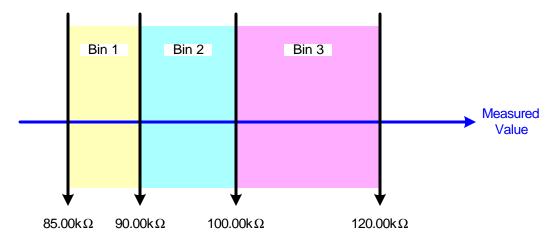
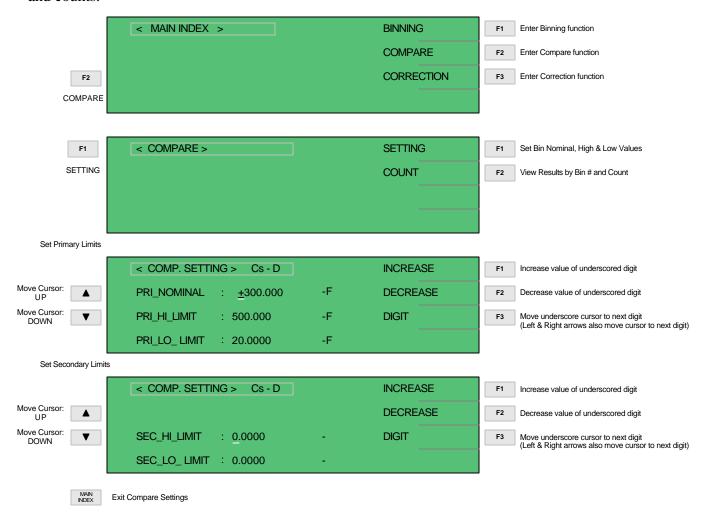


Figure 2-6: Sequential Limits

Operation Page 43 of 87

#### 2.5.2 COMPARE

To set up a comparison test, use the COMPARE function. To access the COMPARE function, press [MAIN INDEX] then press [F2] = COMPARE. Press [F1] = SETTING to set the primary nominal high and low judgment values. Press [F2] = COUNT to view the COMPARE results and counts.

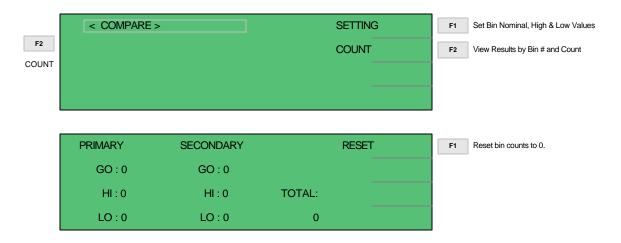


## Continued on Next Page.

Page 44 of 87 Operation

## **Compare Function Continued**

Note that there are two pages within the Compare Setting menu: Primary and Secondary. Use the up and down arrows to move the underscore cursor down the list to each parameter. When all the comparison limits have been entered, press [MAIN INDEX] to exit Compare Setting and return to [COMPARE]. Press [F2] = COUNT to view the Comparison Count by parameter and GO, HI or LO.



# **Notes on Compare Settings:**

Setting COMPARE = ON-VAL will display the primary and secondary readings in addition to a GO (PASS). A LO reading is lower than the set nominal value and a HI reading is higher than the set nominal value.

Setting COMPARE =  $ON-\Delta$  will display the difference between the measured value and the set nominal value. A OO, OO, or OO judgment is also displayed.

Setting COMPARE =  $\boxed{ON-\Delta\%}$  will display the percent difference between the measured value and the set nominal value. A  $\boxed{GO}$ ,  $\boxed{LO}$ , or  $\boxed{HI}$  judgment is also displayed.

Operation Page 45 of 87

#### 2.5.3 CORRECTION

The 1715 instrument provides automatic offset for lead and/or fixture effects. During the offset process a correction is made (subtracted out) as the result of lead leakage current and stored in instrument memory to be applied to ongoing measurements. For maximum measurement accuracy it is recommended that the CORRECTION function be performed on the 1715 instrument after power up, any time the test parameters are changed and any time the test leads or fixture is changed.

Prior to performing the CORRECTION function:

- Allow the instrument to warm up for 15 minutes.
- Connect the Test cables (or fixture) to the output connectors (BNC terminals).
- Program the test steps.

With the instrument in STAND-BY status (MEAS DISPLAY shown on display):

- Press [MAIN INDEX]
- Press [F3] = CORRECTION
- Press [F1] = OPEN (or [F2] = SHORT) to select zero function.
- Press [F1] = SINGLE or [F2] = MULTI to select frequency.
- Follow instructions on display: i.e.: "Open circuit test leads".
- Press [TRIGGER] button.
- Wait while instrument gets CORRECTION value.
- Press [F4] to exit Correction Function.

#### NOTE:

When SINGLE is selected, the 1715 instrument performs an open/short at the programmed test frequency. When MULTI is selected, the 1715 instrument performs the open/short at all 4 test frequencies.

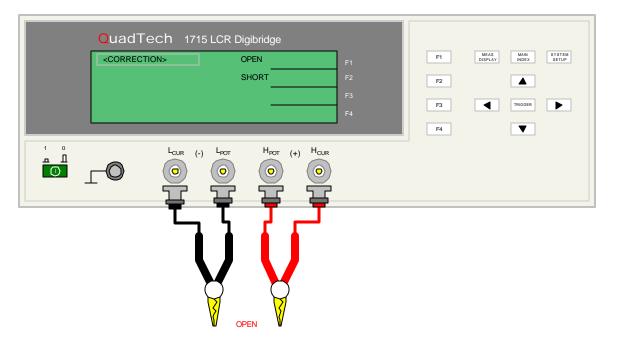


Figure 2-7: OPEN Configuration using Kelvin Clip Test Leads

Page 46 of 87 Operation

# **CORRECTION: OPEN**

Figure 2-7 illustrates the connection of the Kelvin Clip test leads for an open correction. The MAIN INDEX display menus corresponding to the OPEN operation are illustrated below.

	< MAIN INDEX >	BINNING	F1 Enter Binning function
		COMPARE	F2 Enter Compare function
		CORRECTION	F3 Enter Correction function
F3 CORRECTION			
0011112011011			J 1
	< CORRECTION >	OPEN	F1 Perform OPEN correction
F1		SHORT	F2 Perform SHORT correction
OPEN			
			J 1
F1	< CORRECTION OPEN >	SINGLE	F1 Single Frequency test: Programmed F
SINGLE		MULTI	F2 Multiple Frequency test: 100Hz, 120Hz, 1kHz & 10kHz
		ABORT	F4 Exit Correction Function
			J ——
	< CORRECTION OPEN >	SINGLE	F1
TRIGGER	OPEN CIRCUIT TEST LEADS	MULTI	F2
Initiate	THEN PRESS TRIGGER.		
OPEN correction		ABORT	F4
			J
	< CORRECTION OPEN >	SINGLE	F1
	F: 100 Hz	MULTI	F2
F4			F3
EXIT	[PASS] Press 'EXIT' to exit.	EXIT	F4

Operation Page 47 of 87

#### **CORRECTION: SHORT**

Figure 2-8 illustrates the connection of the Kelvin Clip test leads for a short correction. The MAIN INDEX display menus corresponding to the SHORT operation are illustrated below.

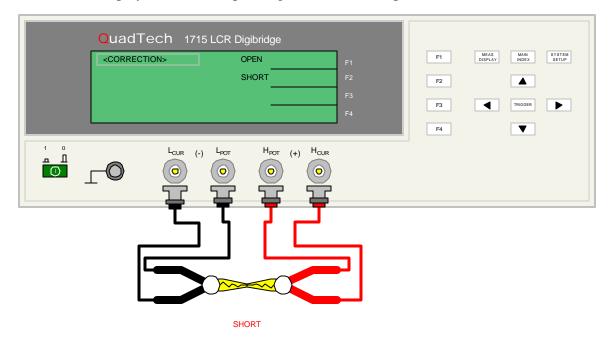
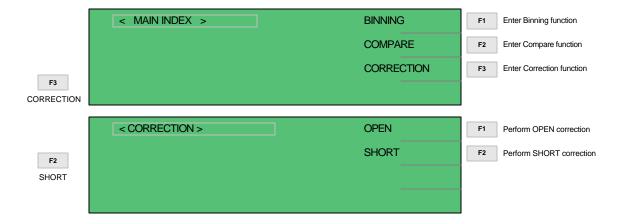


Figure 2-8: SHORT Configuration using Kelvin Clip Test Leads

To access the SHORT correction operation, press [MAIN INDEX] then [F3] = CORRECTION.



Page 48 of 87 Operation

#### **CORRECTION: SHORT - continued**

Press [F3] = SHORT to select the SHORT configuration. Short test leads together then press [TRIGGER] to initiate short correction measurement.



#### NOTE:

Perform the CORRECTION functions any time the test leads or test fixtures are changed or any time the test parameters are changed.

#### NOTE:

When SINGLE is selected, the 1715 instrument performs an open/short at the programmed test frequency. When MULTI is selected, the 1715 instrument performs the open/short at all 4 test frequencies.

Operation Page 49 of 87

#### 2.6 Connection to Device under Test

Figure 2-9 illustrates the connection of the 1715 LCR to a single DUT using the 1700-03 Kelvin Clip Cable lead set. The red Kelvin clip/BNCs are connected between the  $H_{POT}$  and  $H_{CUR}$  (+) terminals on the 1715 unit and the high side of the device under test. The black Kelvin clip/BNCs are connected between the  $L_{POT}$  and  $L_{CUR}$  (-) terminals on the 1715 unit to the low side of the DUT.

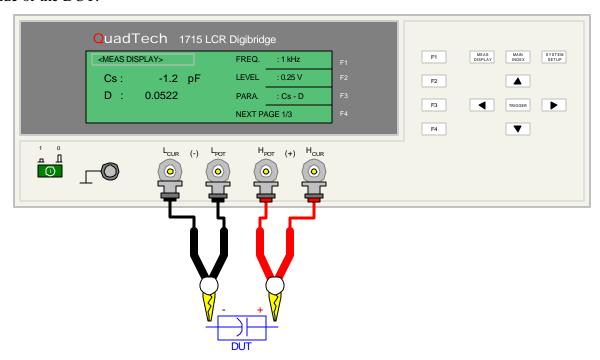


Figure 2-9: 1700-03 Kelvin Clip Test Leads

There are a variety of test leads and fixtures available for the 1715 LCR Meter as listed in Table 2-5 and illustrated in Figure 2-9 through 2-14.

Table 2-5: 1715 LCR Meter Test Leads & Fixtures

Description	QuadTech P/N	Figure
Axial/Radial Component Test Fixture	1700-01	2-10
Axial/Radial Remote Test Fixture	1700-02	2-11
Lead Set: 4 BNC Connectors to 2 Kelvin Clips	1700-03	2-9
Lead Set: 4 BNC Connectors to 4 Banana Plugs	1700-04	2-12
Lead Set: 4 BNC Connectors to Chip Component Tweezers	7000-05	2-13
Low Voltage Chip Component Test Fixture	7000-07	2-14

#### NOTE:

For proper operation, the  $H_{CUR}/H_{POT}/I_{CUR}/I_{POT}$  cable shields must be connected together at the DUT. This connection is already made using the 1715 recommended accessory leads.

If the shields are not tied together, then at higher frequencies a resonance may occur which could cause erroneous capacitance readings.

Page 50 of 87 Operation

# **Connection to Device under Test – continued**

Figure 2-10 illustrates the connection of the 1700-01 axial/radial component test fixture to the 1715 LCR meter.

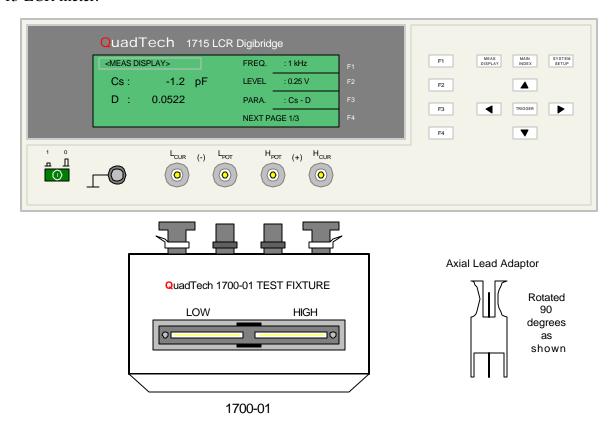


Figure 2-10: 1700-01 Axial/Radial Component Test Fixture

Operation Page 51 of 87

Figure 2-11 illustrates the connection of the 1700-02 axial/radial remote test fixture to the 1715 LCR meter.

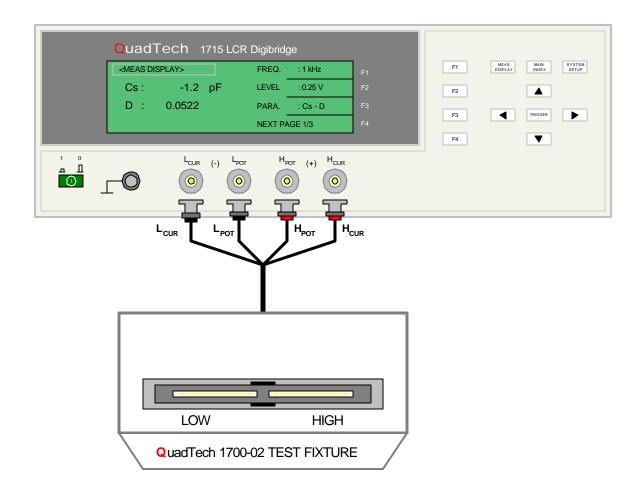


Figure 2-11: 1700-02 Axial/Radial Remote Test Fixture

Page 52 of 87 Operation

Figure 2-12 illustrates the connection of the 1700-04 BNC/Banana Plug lead set to the 1715 LCR meter.

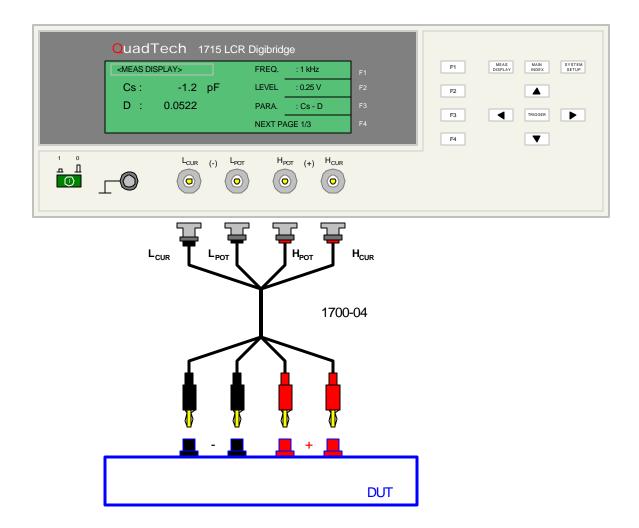


Figure 2-12: 1700-04 BNC/Banana Plug Test Lead Set

Operation Page 53 of 87

Figure 2-13 illustrates the connection of the 1700-05 Component Tweezers cable lead set to the 1715 LCR meter. This provides a 4-terminal connection to even the smallest of devices.

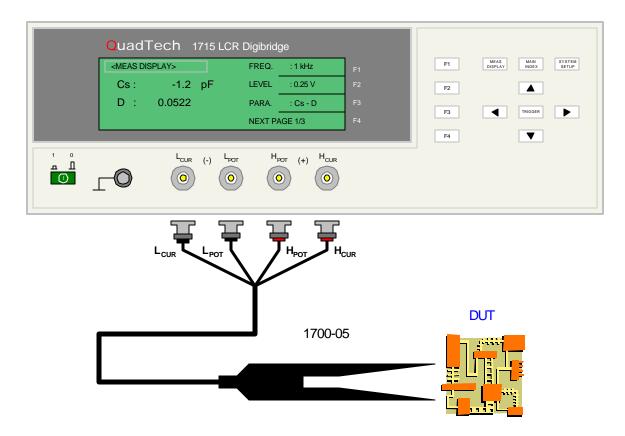


Figure 2-13: 1700-05 BNC to Chip Component Tweezers Cable Lead Set

Figure 2-14 illustrates the 7000-07 Low Voltage Chip Component (SMD) test fixture available for use with the 1715 LCR Meter.



Figure 2-14: 7000-07 Low Voltage Chip Component Test Fixture

Page 54 of 87 Operation

## 2.7 Measurement Procedure

Before a measurement is made verify the following:

- 1. 1715 instrument [POWER] ON.
- 2. 15-minute warm-up.
- 3. Test parameters programmed and shown on MEAS DISPLAY.
- 4. Test cables or fixture connected.
- 5. CORRECTION function initiated.
- 6. Device under test connected.

The operator has the option of performing a test at power-up conditions (test conditions at which the instrument was last powered down) or recalling one of 20 stored test setups. Refer to paragraphs 2.4 - 2.5 for test programming and storage/recall instructions.

#### To initiate a test:

- Press [TRIGGER].
- The test voltage is shut **off** when all test steps are completed,
- **OR** when a test result is judged a FAIL per programmed test limits.
- The test result is displayed on MEAS DISPLAY

The 1715 instrument judges the measurement value based on the BINNING and COMPARE functions set up previously. Refer to paragraphs 2.5.1 and 2.5.2 for instructions on setting these judgment parameters. Upon completion of the test the output voltage is terminated and the display shows the test result.

Operation Page 55 of 87

# **Section 3: Interface**

#### 3.1 RS-232 Interface

## 3.1.1 RS-232 Pin Configuration

The 1715 instrument comes standard with an RS232 Interface for remote operation. Connection is through the black/silver 9-pin connector labeled 'RS232' on the rear panel of the 1715 instrument. Figure 3-1 illustrates the designation of the pins on the RS232 connector. The connection cable must be a 'straight through' cable for the 1715 unit to communicate.

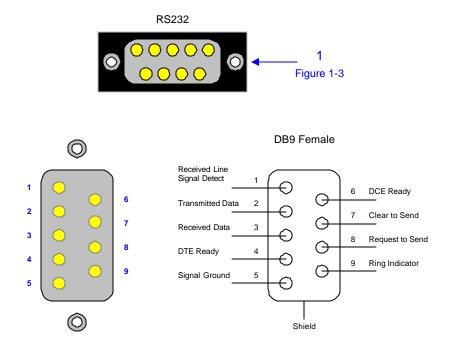


Figure 3-1: RS-232 Interface Pin Configuration

# 3.1.2 RS232 Specifications

Data Bits: 8
Stop Bits: 1

Parity: None, Odd, Even

Baud Rate: 1200, 2400, 4800, 9600, 19200 0r 38400bps, Software selectable

EOS: LF or CR + LF

Echo: Off

Interface Page 57 of 87

Refer to paragraph 2.3.3.10. Setting the Baud Rate is done in the SYSTEM CONFIGURATION function under SYSTEM SETUP settings:

- From the STAND BY display, press [SYSTEM SETUP]
- Press [F3] = SYSTEM CONFIG.
- Press  $[\downarrow]$  = until the box next to BAUD RATE is highlighted.
- Press [F1] = INCREASE or [F2] = DECREASE to select baud rate.
- Press [F4] to EXIT

## **3.1.3 RS232 Commands**

The command set for the RS232 interface is the same as the IEEE-488 interface command set listed in paragraphs 3.2.3 through 3.2.5 of this instruction manual.

**NOTE** 

CR + LF are necessary end codes for the RS232 commands.

**NOTE** 

Press [F1] [F4] [SYSTEM SETUP] to get the 1715 instrument out of remote mode.

Page 58 of 87 Interface

## 3.1.4 Sample QuickBasic Program

```
REM This is a simple program for the 1715 LCR meter
REM This is for RS232 communication and reads *idn from 1715
REM You must use a straight through cable
REM You must enable RS232 interface in System Setup menu of 1715
REM baud rate = 9600
REM to change com1, com2 in OPEN statement depending upon your computer
PRINT "Calculating Delay Loops ....."
REM delay correction routine
q = 1
DO WHILE ENVIRON$(q) <> ""
    IF LEFT$(ENVIRON$(q), 7) = "MACHINE" THEN
      mn = VAL(RIGHT$(ENVIRON$(q), 1))
      mn$ = RIGHT$(ENVIRON$(q), 1)
    END IF
   q = q + 1
LOOP
t1 = TIMER
s = 0
FOR I = 1 \text{ TO } 30000
NEXT I
t2 = TIMER
k = t2 - t1
REM open com port as #1
OPEN "COM1:9600,n,8,1,cs,ds" FOR RANDOM AS #1:
REM Get identification string from 1715 Series
FOR j = 1 TO 100000: NEXT j
PRINT #1, "*idn?"; CHR$(13); CHR$(10)
FOR j = 1 TO 100000: NEXT j
GOSUB cget
r45$ = INPUT$(x, #1)
PRINT r45$
CLOSE #1
PRINT "End of Program"
END
' subroutine to get serial input loop until first character is received
DO WHILE (LOC(1) = 0)
FOR j = 1 TO k2: NEXT j
LOOP
' then get the rest of the string
y = x + LOC(1)
DO WHILE (x <> y)
y = x
FOR j = 1 TO k2 / 10: NEXT j
x = LOC(1)
LOOP
'PRINT x
RETURN
```

Interface Page 59 of 87

## 3.2 IEEE-488 Interface

## 3.2.1 Pin Configuration

An IEEE-488 Interface (illustrated in Figure 3-2) is an available option for the 1715 instrument. Connection is through the blue 24-pin connector labeled 'IEEE-488 INTERFACE' on the rear panel of the 1715 instrument. This interface can be used to connect a system containing a number of instruments and a controller in which each meets IEEE Standard 488.2 (Standard Digital Interface for Programmable Instrumentation).

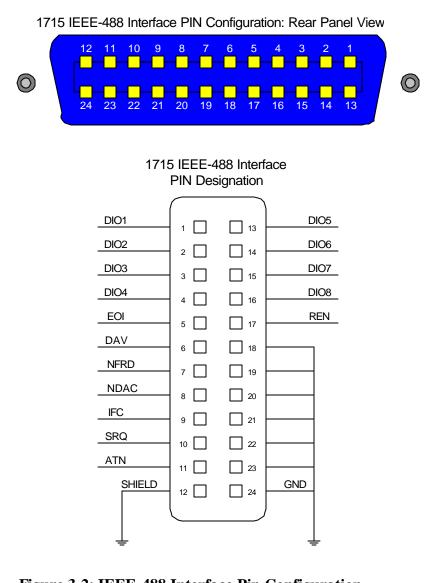


Figure 3-2: IEEE-488 Interface Pin Configuration

Page 60 of 87 Interface

Table 3-1 lists the IEEE-488 Interface pin designations by pin number, signal name and pin function. Bus and driver information is also listed.

**Table 3-1: IEEE-488 Interface Pin Designations** 

Bus	Driver	Signal	Pin Number	Function		
	3 States	Name DAV	6	Low State: "Data is Available" and valid on DI01		
Handshake	3 States	DAV	0	through DI08		
nds	Open	NRFD	7	Low State: At least one Listener on the bus is "Not		
sha	Collector	NKID	<b>'</b>	Ready For Data"		
ke	Open	NDAC	8	Low State: At least one Listener on the bus is "Not		
	Collector	1,2110		Accepting Data"		
	3 States	ATN	11	"Attention" specifies 1 of 2 uses for the DI01 through		
Control				DI08 lines:		
tre				Low State: Controller command messages		
				High State: Data bytes from the Talker device		
	3 States	IFC	9	"Interface Clear"		
				Low State: Returns portion of interface system to a		
				known quiescent state		
	Open	SRQ	10	"Service Request"		
	Collector			Low State: A Talker or Listener signals (to the		
				controller) need for attention in the midst of the		
				current sequence of events.		
	3 States	REN	17	"Remote Enable"		
				Low State: Enables each device to enter remote mode		
				when addressed to listen.		
	2.04.4	FOI		High State: All devices revert to Local control.		
	3 States	EOI	5	"End of Identify"		
				If ATN is in HIGH state, then EOI LOW state		
				indicates the end of a multiple-byte data transfer		
				sequence.  If ATN is in LOW state, then EOI LOW state		
				indicates a parallel poll.		
	Open	DI01	1	The 8-Line Data Bus.		
Data	Collector	DI02	2	The o Diffe Data Data.		
2	2011001	DI03	3	If ATN is in LOW state, then the bus conveys		
		DI04	4	interface messages.		
		DI05	13	If ATN is in HIGH state, then the bus conveys device-		
		DI06	14	dependent messages. (Example: carries remote		
		DI07	15	control commands from the controller or from a talker		
		DI08	16	device)		

Interface Page 61 of 87

# 3.2.2 IEEE-488 Interface Function Codes and Messages

The IEEE-488 (GPIB) address is defined under the SYSTEM SETUP in the SYSTEM CONFIG menu. Press [SYSTEM SETUP], then the numerical key [F3] to enter the SYSTEM CONFIG menu. Press down arrow [↓] to enter the GPIB ADDRESS code. To select a new IEEE-488 address, use the function keys. Refer to paragraph 2.3.3.6 for more information. The default setting for the IEEE address is 17.

Table 3-2 defines the IEEE-488 interface codes and their function. Table 3-3 defines the IEEE-488 interface messages the 1715 instrument responds to and their function.

**Table 3-2: IEEE-488 Interface Functions** 

Code	Function	
SH1	Source Handshake (Talker)	
AH1	Acceptor Handshake (Listener)	
T6	Basic Talker Function	
	Serial Poll Function	
	Listener-specified Talker Release Function	
	No TALK-ONLY Function	
L4	Basic Listener Function	
	Talker-specified Listener Release Function	
SR1	Service Request Function	
RL1	All Remote/Local Functions	
PP0	No Parallel Poll Function	
DC1	Device Clear Function	
DT1	Device Trigger Function	
C0	No Controller Functions	

**Table 3-3: IEEE-488 Interface Messages** 

Interface Message	Function	Description
GTL	Go To Local	Only addressed devices that receive this command are set to local mode.  Cancels the remote control mode, making the front panel switches operative.

NOTE
Press [F1] [F4] [SYSTEM SETUP] to get the 1715 instrument out of remote mode.

Page 62 of 87 Interface

Table 3-4 lists the IEEE-488 interface commands the 1715 instrument accepts to set or query a parameter value. Paragraphs 3.2.3 through 3.2.5 detail command function, format, return value and description.

**Table 3-4: IEEE-488 Commands** 

Command	Name	Function	<b>Output Format</b>
*CLS	Clear Status	Clear standard event status	
		register. Clear status bit group	
		register except for bit 4 (MAV)	
*ESE	Event Status Enable	Enable standard event status	0 - 255
		register value.	
*ESE?	Event Status Enable	Query standard event status of	0 - 255
		device enable register	
*ESR?	Event Status Register	Query standard event register	0 - 255
		value of device. After this	
		command, the standard register is	
		cleared to 0.	
*IDN?	Identification	Query/Read basic device data.	4 ID:
		(A comma separates the	Manufacturer,
		identification fields.)	Device Model,
			Serial Number,
			Firmware Version
*RST	Reset	Reset Device.	
*SRE	Service Request Enable	Enable service request register	0 - 255
		value.	
*SRE?	Service Request Enable	Query/Read service request	0 - 255
		register value.	
*TRG	Trigger Bus	Trigger the 1715 instrument	
*TST?	Self Test	Perform self test & report error	0 = no error

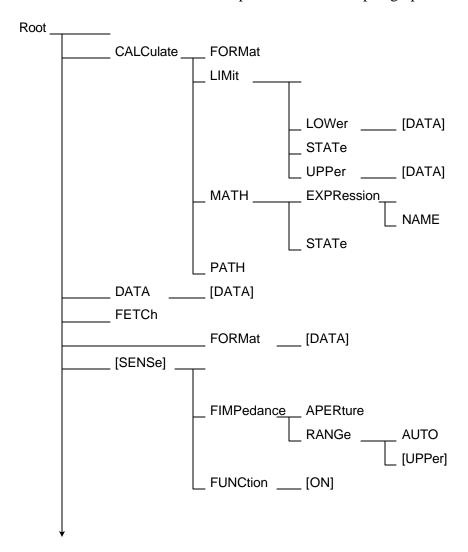
# **NOTE**

Press [F1] [F4] [SYSTEM SETUP] to get the 1715 instrument out of remote mode.

Interface Page 63 of 87

## **3.2.3 IEEE-488** Commands

Figure 3-2 illustrates the programming commands accepted by the IEEE-488 interface of the 1715 instrument. The commands are written in tabular format as a single reference to view all the commands. The command format and examples are detailed in paragraphs 3.2.4 - 3.2.5.



Continued on next page

Figure 3-2a: IEEE-488 Commands

Page 64 of 87 Interface

Figure 3-2 Continued: Tabular format of IEEE-488 Commands

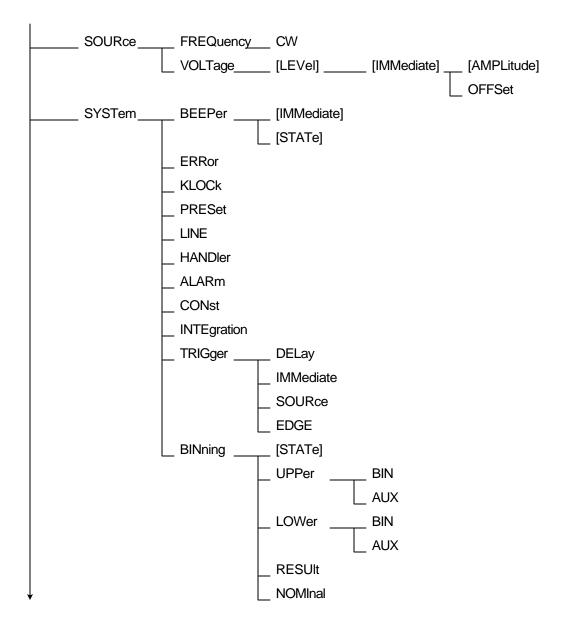


Figure 3-2b: IEEE-488 Commands

Interface Page 65 of 87

#### 3.2.4 IEEE-488 Command Format

The IEEE-488 commands are configured in Root format. There are six levels of the instruction from top to bottom. Follow the specific path (as illustrated in Figure 3.2) to configure a specific command. The colon at the beginning of each line denotes that all line signals are root. Use a colon (:) to separate levels. Use the semicolon (;) to separate two commands on the same line.

For example, to format the command for the NAME function, use this path:

:CALCulate:MATH:EXPRession:NAME

To format the NAME and CATalog function, use a single command:

:CALCulate:MATH:EXPRession:NAME

If the command is a setting, then put the parameter after the instruction. If the command is an inquiry, then put a question mark (?) after the instruction.

For example, to set the frequency to 1kHz:

:SOURce:FREQuency 1000

To inquire what the frequency is set to:

:SOURce:FREQuency?

The lowercase letters and portion in parenthesis can be omitted so the above instruction can be rewrites as:

:SOUR:FREQ;

The Ending Code can be any type in Table 3-5.

**Table 3-5: IEEE-488 Interface Ending Codes** 

<b>Ending Code</b>
[CR] (0Dh)
[LF] (0Ah)
[CR] (0Dh) + [LF] (0Ah)

Page 66 of 87 Interface

## 3.2.5 IEEE-488 Commands - Detailed

The IEEE commands listed in Figure 3-2 are detailed in paragraphs 3.2.5.1 - 3.2.5.51 including command, parameter, return value, function, and description. Note: Numerical data is transferred via one of three methods: integer format, fixed decimal format or floating point decimal format. Refer to Figure 3-3.

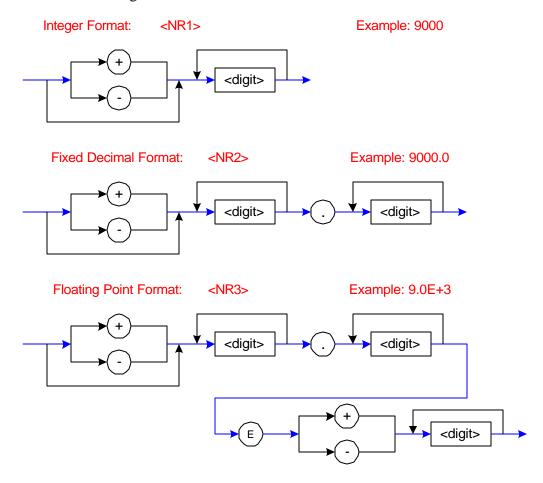


Figure 3-3: Numerical Data Transfer

Interface Page 67 of 87

#### 3.2.5.1 CALCulate1:FORMat

Instruction: CALCulate1:FORMat

Parameter: {REAL | MLINear | CP | CS | LP | LS | ZS | RS | RP} Return Value: {REAL | MLINear | CP | CS | LP | LS | ZS | RS | RP} Function: Set or Query the primary measurement parameter.

Description: REAL Impedance, Real

MLINear Impedance, absolute value CP Equivalent parallel capacitance CS Equivalent series capacitance Equivalent parallel inductance LP LS Equivalent series inductance **7**S Equivalent series impedance RS Equivalent series resistance RP Equivalent parallel resistance

Example: :CALC1:FORM Ls 'set primary parameter to "Ls"

#### 3.2.5.2 CALCulate2:FORMat

Instruction: CALCulate2:FORMat

Parameter: {IMAGinary | PHASe | D | Q | REAL | RS | XS} Return Value: {IMAGinary | PHASe | D | Q | REAL | RS | XS}

Function: Set or Query the secondary measurement parameter.

Description: IMAGinary Impedance, Imaginary

PHASe Phase angle
D Dissipation factor
Q Quality factor
REAL Impedance, Real

RS Equivalent series resistance

XS Equivalent series reactance (imaginary)

Example: :CALC2:FORM Xs 'set secondary parameter to "Xs"

# 3.2.5.3 CALCulate{1½2}:LIMit:LOWer[:DATA]

Instruction: CALCulate{1 | 2}:LIMit:LOWer[:DATA]

Parameter: {The lower limit value | MAXimum | MINimum}

Return Value: The lower limit value, the format is <NR3> (Floating point)

Function: Set or query the lower limit value.

Description: MINimum -9.999E14

MAXimum 9.999E14

Example: :CALC1:LIM:LOW 8 'set primary low limit to compare to "8"

Page 68 of 87 Interface

## 3.2.5.4 CALCulate{1½2}:LIMit:STATe

Instruction: CALCulate{1 | 2}:LIMit:STATe

Parameter:  $\{ON(1) \mid OFF(0)\}$ 

Return Value: {1 | 0}

Function: Set or query if the Compare function is ON or OFF.

Description: ON (1) Turn on Compare function

OFF (0) Turn off Compare function

Example: :CALC1:LIM:STATE OFF

# 3.2.5.5 CALCulate{1½2}:LIMit:UPPer[:DATA]

Instruction: CALCulate{1 | 2}:LIMit:UPPer[:DATA]

Parameter: {The upper limit value | MAXimum | MINimum}

Return Value: The upper limit value, the format is <NR3> (Floating point)

Function: Set or query the upper limit value.

Description: MINimum -9.999E14

MAXimum 9.999E14

Example: :CALC2:LIM:UPPER 10 'set upper limit to compare to "10"

# 3.2.5.6 CALCulate{1½2}:MATH:EXPRession:NAME

Instruction: CALCulate {1 | 2}: MATH: EXPRession: NAME

Parameter: {DEV | PCNT}
Return Value: {DEV | PCNT}

Function: Set the Compare function value to deviation or percent deviation.

Example: :CALC1:MATH:EXPR:NAME PCNT

# 3.2.5.7 CALCulate{1½2}:MATH:STATe

Instruction: CALCulate{1 | 2}:MATH:STATe

Parameter:  $\{ON(1) \mid OFF(0)\}$ 

Return Value: {1 | 0}

Function: Set or query if CALCulate {1 | 2}: MATH:EXPRession:NAME is ON or OFF.

Description: ON (1) Turn on CALCulate {1 | 2}: MATH: EXPRession: NAME

OFF (0) Turn off CALCulate {1 | 2}: MATH:EXPRession:NAME

Example: :CALC1:MATH:STATe ON

## 3.2.5.8 :DATA[:DATA]

Instruction: :DATA[:DATA]

Parameter: MAXimum MINimum

Return Value: The compare data of primary in <NR3> format (-9.999E14 to 9.999E14)

Function: Query the compare data of the primary parameter. Example: :DATA 9 'set nominal value for compare to "9"

Interface Page 69 of 87

#### 3.2.5.9 **FETCh?**

Instruction: FETCh? Parameter: None

Return Value: <STATE>, <DAT1>, <DAT2>, <CMP1>, <CMP2> Function: Get the result from the INITiate or \*trg function.

Description: <STATE> Measuring status

1 Normal2 Overload

3 DUT disconnected

<DAT1> test value of primary parameter
<DAT2> test value of secondary parameter
When the Compare function is enabled, results are:
<CMP1> comparison value of primary parameter
<CMP2> comparison value of secondary parameter

No secondary parameter
Test value in range
Test value too high
Test value too low
DUT disconnected

When the BINNING function is enabled, results are:

<BIN> The sorting result

O Secondary parameter FAILED

1 ~ 8 Primary Parameter and Secondary Parameter PASSED

9 Primary Parameter FAILED

Example: :FETCH?

Response: 0, 6.623456E-06, 2.293633E+00

## 3.2.5.10 [:SENSe]:FIMPedance:APERature

Instruction: [:SENSe]:FIMPedance:APERature

Parameter: 0.025 (Fast), 0.065 (Medium), 0.500 (Slow) Return Value: 0.025 (Fast), 0.065 (Medium), 0.500 (Slow)

Function: Set or query the measurement speed.

Example: :SENSe:FIMP:APER SLOW

## 3.2.5.11 [:SENSe]:FIMPedance:RANGe:AUTO

Instruction: [:SENSe]:FIMPedance:RANGe:AUTO

Parameter:  $\{ON(1) \mid OFF(0)\}$ 

Return Value: {1 | 0}

Function: Set or query if the Auto Range is ON or OFF.

Description: ON (1) Turn on Auto Range

OFF (0) Turn off Auto Range

Example: :SENSe:FIMP:RANGe:AUTO ON

Page 70 of 87 Interface

## 3.2.5.12 [:SENSe]:FIMPedance:RANGe[:UPPer]

Instruction: [:SENSe]:FIMPedance:RANGe[:UPPer]
Parameter: {Measured value range | UP | DOWN}

Unit: [MOHM | kOHM | OHM | mOHM], default is OHM

Return Value: {Measured value range} in <NR3> format

Function: Set or query which Measurement Range is enabled.

Range Values: 100000, 10000, 1000, 100 and 10. Example: :SENSe:FIMP:RANGe 1000

## 3.2.5.13 SOURce:FREQuency[:CW]

Instruction: SOURce:FREQuency[:CW]

Parameter: Test Frequency

Unit: [Hz kHz], default is Hz

Return Value: {Test Frequency} in <NR3> format Function: Set or query the test frequency. Range Values: 100Hz, 120Hz, 1kHz and 10kHz

Example: :SOURce:FREQ 10000

## 3.2.5.14 SOURce:VOLTage[:LEVel][:IMMediate][AMPLitude]

Instruction: SOURce:VOLTage[:LEVel][:IMMediate][AMPLitude]

Parameter: Test Voltage

Return Value: {Test Voltage} in <NR3> format Function: Set or query the test voltage.

Range Values: 0.25 and 1.0V Example: :SOURce:VOLT 1.0

#### 3.2.5.15 SYSTem:BEEPer:STATe

Instruction: SYSTem:BEEPer:STATe

Parameter:  $\{OFF(0) \mid ON, LOW(1) \mid ON, HIGH(2)\}$ 

Return Value:  $\{0 \mid 1 \mid 2\}$ 

Function: Set the loudness of the beeper.

Example: :SYSTem:BEEPer:STATe 1 'set beeper to "low"

#### **3.2.5.16 SYSTem:ERRor?**

Instruction: SYSTem:ERRor?

Parameter: None

Return Value: Error message

Function: Query if there are any system errors.

Example: :SYSTem:ERRor? Response: "0, "No Error""

Interface Page 71 of 87

#### **3.2.5.17 SYSTem:KLOCk**

Instruction: SYSTem:KLOCk Parameter: {ON (1) | OFF (0)}

Return Value: {1 | 0}

Function: Set or query if the Key Lock function is ON or OFF.

Description: ON (1) Turn on Key Lock

OFF (0) Turn off Key Lock

Example: :SYSTem:KLOCk 0 'set key lock "Off"

## 3.2.5.18 SYS Tem:LFRequency

Instruction: SYSTem:LFRequency

Parameter: {50 | 60} Return Value: {50 | 60}

Function: Set or query if the Line Frequency.

Example: :SYSTem:LFRequency 50

#### **3.2.5.19 SYSTem:PRESet**

Instruction: SYSTem:PRESet

Parameter: None Return Value: None

Function: Set the instrument to initial default values.

Example: :SYSTem:PRESet

#### 3.2.5.20 SYSTem:HANDler

Instruction: SYSTem:HANDler Parameter: {CLEAr | HOLD} Return Value: {CLEAr | HOLD}

Function: Set the Handler to clear result or hold result for each test.

Example: :SYSTem:HANDler CLEAr

## 3.2.5.21 SYSTem:ALARm

Instruction: SYSTem:ALARm
Parameter: {PULSe | CONTinuous}
Return Value: {PULSe | CONTinuous}

Function: Set the mode the alarm will sound in.

Example: :SYSTem:ALARm PULSe

Page 72 of 87 Interface

#### 3.2.5.22 TRIGger:DELay

Instruction: TRIGger:DELay Parameter: Trigger Delay Time Unit: [MS | S], default is S

Return Value: {Trigger Delay Time} in <NR3> format Set or query the trigger delay time. Function:

0 ~ 9999ms Range Values:

:TRIGger:DELay .500 'set trigger delay to "500ms" Example:

#### 3.2.5.23 TRIGger:SOURce

Instruction: TRIGger:SOURce

{BUS | EXTernal | MANual } Parameter: Return Value: {BUS | EXTernal | MANual } Set or query the trigger mode. Function: Bus trigger Description: BUS **EXTernal** External trigger

Manual trigger MANual

Example: :TRIGger:SOURce MANual

#### 3.2.5.24 TRIGger:EDGE

Instruction: TRIGger:EDGE Parameter: {FALLing | RISIngl} {FALL RISI} Return Value:

Set or query the trigger edge. Function: Example: :TRIGger:EDGE FALLing

#### 3.2.5.25 BINNing:UPPer:BIN{1~8}

Instruction: BINNing:UPPer:BIN{1~8} Parameter:  $\{? \mid , < \text{number} > (NR3 \text{ mode})\}$ Return Value: {The high limit of each BIN}

Set the high limit of each bin within the value +999.99 to -999.99%. Function:

To set BIN2 to +99.89%, send the command BINNing:UPPer:BIN2,+99.89

and send command BINNing:UPPer:BIN2? for query.

'set upper limit for Bin 1 to "10%"" Example: :BINNing:BIN1 10

Interface Page 73 of 87

# 3.2.5.26 BINNing:UPPer:AUX

Instruction: BINNing:UPPer:AUX

Parameter: {The high limit of the secondary parameter (NR3 mode)}

Return Value: {The high limit of the secondary parameter}

Function: Set the AUX HI limit for BINNING of secondary parameter.

Example: :BINNing:UPPer:AUX 10 'set secondary high limit to "10"

# **3.2.5.27 BINNing:LOWer:BIN{1~8}**

Instruction: BINNing:LOWer:BIN{1~8}
Parameter: {? | , <number> (NR3 mode)}
Return Value: {The low limit of each BIN}
Function: Set the low limit of each bin.

Example: :BINNing:LOW:BIN2 8 'set lower limit for Bin 2 to "8%"

# 3.2.5.28 BINNing:LOWer:AUX

Instruction: BINNing:LOWer:AUX

Parameter: {The low limit of the secondary parameter (NR3 mode)}

Return Value: {The low limit of the secondary parameter}

Function: Set the AUX LO limit for BINNING of secondary parameter. Example: :BINNing:LOWer:AUX 8 'set secondary low limit to "8"

# 3.2.5.29 BINNing:NOMinal

Instruction: BINNing:NOMinal

Parameter: {The nominal of the primary parameter (NR3 mode)}

Return Value: {The nominal of the primary parameter}

Function: Set the NOMINAL limit for BINNING of primary parameter. Example: :BINNing:NOMinal 100 'set nominal value to "100"

## **3.2.5.30 BINNIng:STATe**

Instruction: BINNing:STATe
Parameter: {ON (1) | OFF (0)}

Return Value: {1 | 0}

Function: Set the BINNING function ON or OFF.

Example: :BINNing:STATe ON

Page 74 of 87 Interface

# 3.2.6 Binning Example

Here is an example to program the bin limits for a binning operation. In this example Bin1 has a high/low limit of  $\pm 1.2\%$ . Bin2 has a high/low limit of  $\pm 2.2\%$ . Both nested around the nominal value of  $100 \text{m}\Omega$ .

:BINing:NOMInal 100e3; Sets the nominal value to 100m :BINning:LOWer:AUX 1; Sets the AUX-HI limit value to 1 :BINning:LOWer:BIN1,+1.2; Sets the Bin1 HI limit value to +1.2% :BINning:UPPer:BIN2,+2.2; Sets the Bin2 HI limit value to +2.2% :BINning:LOWer:BIN2,-2.2; Sets the Bin2 LO limit value to -2.2%

:BINning:STATe ON; Enables Binning function :BINning:RESUlt? Query the Binning result

Interface Page 75 of 87

# 3.2.7 Compare Example

Here is an example to program the nominal, high and low limits for a compare operation. In this example the 1715 instrument is programmed with the primary parameter Rs and the secondary parameter Q at 1kHz and 1V. The auto range is OFF and the  $100\Omega$  Range is selected. The primary nominal value is set to  $24.9\Omega$ , the primary low limit is set to  $20\Omega$  and the primary high limit is set to  $30\Omega$ . The Compare display selected is "ON-VAL". Note: the Compare function is turned on **after** the limits are set.

```
NI = 0
datakeep$ = "no"
passall$ = "yes"
If NI = 1 Then
Open "gpib0" For Output As #1
Open "gpib0" For Input As #2
Print #1, "ABORT"
Print #1, "RESET"
Print #1, "gpibeos If"
Else
Open "\dev\ieeeout" For Output As #1
IOCTL #1, "BREAK"
Print #1, "RESET"
Open "\dev\ieeein" For Input As #2
Print #1, "TERM LF"
End If
K2 = 1000
fr = 100000
cmdl$ = "C"
Print #1, "output 17; TRIG:SOUR ext"
For G = 1 To k2: Next G
Print #1, "output 17; :SOUR:FREQ "; 1000
For G = 1 To k2: Next G
Print #1, "output 17; :SENS:FIMP:APER SLOW"
For G = 1 To k2: Next G
Print #1, "output 17; :SOUR:VOLT 1.0"
For G = 1 To k2: Next G
Print #1, "output 17; :CALC2:FORM Q"
For G = 1 To k2: Next G
Print #1, "output 17; :CALC1:FORM RS"
For G = 1 To k2: Next G
Rem now for bin limits
Print #1, "output 17; :data 24.9;"
For G = 1 To k2: Next G
Print #1, "output 17; :sens:fimp:rang:auto off"
For G = 1 To k2: Next G
Print #1, "output 17; :sens:fimp:rang 100"
For G = 1 To k2: Next G
Print #1, "output 17; :CALC1:lim:lower 20"
For G = 1 To k2: Next G
Print #1, "output 17; :CALC1:lim:upper 30"
For G = 1 To k2: Next G
Print #1, "output 17; :CALC1:lim:state on"
For G = 1 To k2: Next G
Print #1, "output 17; :CALC1:math:state on"
For G = 1 To k2: Next G
Print #1, "output 17; :CALC1:math:expr:name:dev"
For G = 1 To k2: Next G
```

Page 76 of 87 Interface

# 3.2.8 Sample IEEE-488 Basic Program

Included herein is a sample Basic program.

# NOTE:

Refer to: <a href="http://www.quadtech.com">http://www.quadtech.com</a> for the latest sample programs that may be available.

```
NI = 0
IF NI = 1 THEN
OPEN "gpib0" FOR OUTPUT AS #1
OPEN "gpib0" FOR INPUT AS #2
PRINT #1, "ABORT"
PRINT #1, "RESET"
PRINT #1, "gpibeos lf"
ELSE
OPEN "\dev\ieeeout" FOR OUTPUT AS #1
IOCTL #1, "BREAK"
PRINT #1, "RESET"
OPEN "\dev\ieeein" FOR INPUT AS #2
PRINT #1, "TERM LF"
END IF
k2 = 1000
fr = 100000
Cmdl$ = "C"
Print "Configuring the 1715"
PRINT #1, "output 17; TRIG:SOUR MAN"
FOR g = 1 TO k2: NEXT g
PRINT #1, "output 17; :SOUR:FREQ "; fr
FOR g = 1 TO k2: NEXT g
PRINT #1, "output 17; :SENS:FIMP:APER SLOW"
FOR g = 1 TO k2: NEXT g
PRINT #1, "output 17; :SOUR:VOLT 1.0"
FOR q = 1 TO k2: NEXT q
PRINT #1, "output 17; :FIMP:RANG:AUTO ON"
FOR g = 1 TO k2: NEXT g
PRINT #1, "output 17; :CALC1:FORM REAL"
FOR g = 1 TO k2: NEXT g
PRINT #1, "output 17; :CALC2:FORM IMAG"
FOR g = 1 TO k2: NEXT g
IF cmdl$ = "C" THEN
        PRINT #1, "output 17; :CALC2:FORM D"
       PRINT #1, "output 17; :CALC1:FORM CP"
ELSEIF cmdl$ = "R" THEN
       PRINT #1, "output 17; :CALC2:FORM Q"
PRINT #1, "output 17; :CALC1:FORM RS"
ELSEIF cmdl$ = "L" THEN
        PRINT #1, "output 17; :CALC1:FORM LS"
        PRINT #1, "output 17; :CALC2:FORM Q"
END IF
PRINT #1, "output 17;*TRG"
FOR q = 1 TO k2: NEXT q
PRINT #1, "output 17; fetch?"
PRINT #1, "enter 17"
REM get and parse return data
INPUT #2, s1$
INPUT #2, f3$
INPUT #2, f6$
PRINT "Data is: ", s1$, f3$, f6$
```

Interface Page 77 of 87

## 3.3 Handler Interface

 $\bigcirc$ 

A Handler interface (Figure 3-4) is an available option for the 1715 instrument. Connection is made through the blue 24-pin connector labeled "HANDLER" on the rear panel of the 1715 instrument. Figure 3-5 illustrates a simple START switch using the Handler interface.

1715 HANDLER Interface PIN Configuration: Rear Panel View

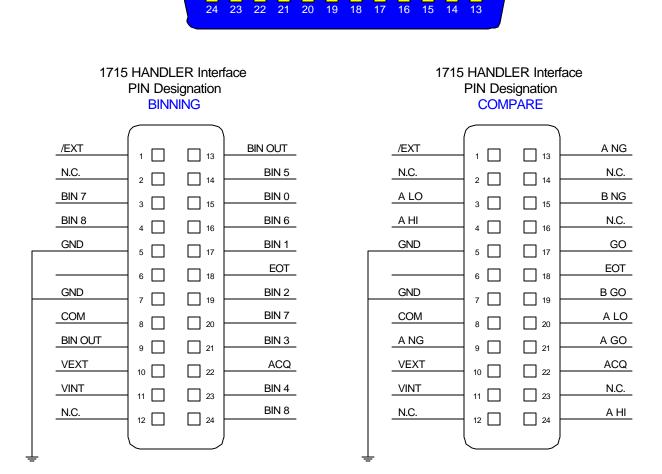


Figure 3-4: Handler Interface Pin Configuration

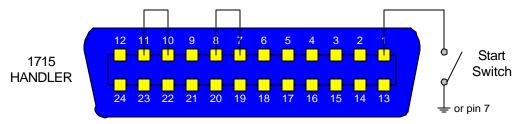


Figure 3-5: Simple Start Switch

Page 78 of 87 Interface

Paragraph 2.3.4.5 contains the instructions for changing the Handler mode. Paragraphs 2.3.4.7 and 2.3.4.8 contain instructions for setting the Trigger Delay time and selecting the Trigger Edge. Figure 3-6 illustrates the Trigger function.

Start measurement on RISING or FALLING edge

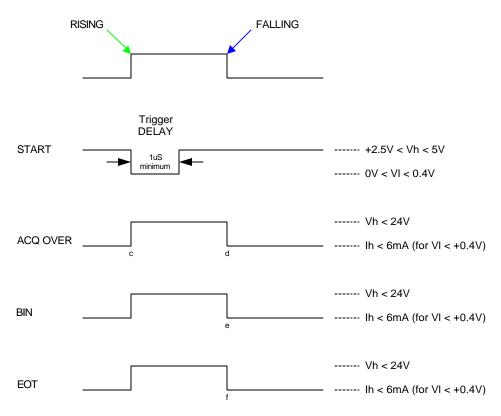


Figure 3-6: Trigger

## **Output Signals**

The output lines of the 1715 Handler interface are open collector drivers that pull each signal line to a low voltage, signal ground when the signal is active (true). Each external line should be pulled up (with a resistor) to a positive voltage between 5V and 24V. The pull-up resistor must limit the current to < 6mA for a signal of a comparison function and to < 5mA for a control signal (EOT).

# **Input Signal**

The input signal to the 1715 Handler interface is active low and requires a positive external voltage to pull the signal down below 0.4V, ground.

Interface Page 79 of 87

# 3.3.1 Handler Pin Assignments for Binning Operation

Table 3-6 lists the pin assignments when the handler interface on the 1715 instrument is performing a Binning operation. The device under test is sorted by test value. The test limits can be set as absolute value or percent value.

Table 3-	6:	Handler	Pin	<b>Assignments</b>	for	Binning

Pin	Name	Description
1	/EXT	External trigger
2	X	No connection
3, 20	BIN 7	Primary parameter pass (within Bin 7 limits)
4, 24	BIN 8	Primary parameter pass (within Bin 8 limits)
5 - 7	GND	Chassis Ground
8	COM	Common Ground
9, 13	BIN OUT	Primary parameter fail
10	VEXT	External DC voltage: 5V ~ 24V
11	VINT	Internal DC voltage: +5V
12	N.C.	No Connection
14	BIN 5	Primary parameter pass (within Bin 5 limits)
15	BIN 0	Secondary parameter fail
16	BIN 6	Primary parameter pass (within Bin 6 limits)
17	BIN 1	Primary parameter pass (within Bin 1 limits)
18	EOT	End of Test
19	BIN 2	Primary parameter pass (within Bin 2 limits)
21	BIN 3	Primary parameter pass (within Bin 3 limits)
22	ACQ	Received data, ready to accept next
23	BIN 4	Primary parameter pass (within Bin 4 limits)

# Compatibility with 1658-9620 & 1658-9630

(Handler Interface for the 1689, 92, 93 & 59 Digibridges):

Short pins 7 & 8 together and short pins 10 & 11 together to make the Handler compatible.

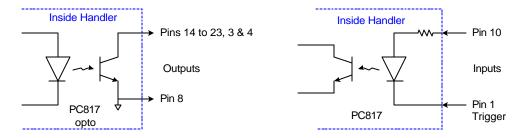


Figure 3-7: Handler I/O Pins

Page 80 of 87 Interface

# 3.3.2 Handler Pin Assignments for Compare Operation

Table 3-7 lists the pin assignments when the handler interface on the 1715 instrument is performing a Compare operation. The device under test is being compared against a standard of known value. High and low limits can be defined as absolute value or percent value.

**Table 3-7: Handler Pin Assignments for Compare** 

Pin	Name	Description
1	/EXT	External Trigger
2	X	No connection
3, 20	A LO	Primary parameter fail low (test value below low limit)
4, 24	A HI	Primary parameter fail high (test value above high limit)
5 - 7	GND	Chassis Ground
8	COM	Common Ground
9, 13	A NG	Primary parameter fail (No Good)
10	VEXT	External DC voltage: 5V ~ 24V
11	VINT	Internal DC voltage: +5V
12	X	No connection
14	X	No connection
15	B NG	Secondary parameter fail (No Good)
16	X	No connection
17	GO	Primary and Secondary parameters pass
18	EOT	End of Test
19	B GO	Secondary parameter pass (test value within limits)
21	A GO	Primary parameter pass (test value within limits)
22	ACQ	Received data, ready to accept next
23	X	No connection

Interface Page 81 of 87

# **Section 4: Service & Calibration**

### 4.1 General

Our warranty (at the front of this manual) attests to the quality of materials and workmanship in out products. If malfunction should be suspected, or other information desired, applications engineers are available for technical assistance. Applications assistance is available in the U.S. by calling (978) 461-2100 and asking for Applications Support. For support outside of the United States please contact your local QuadTech Distributor.

### 4.2 Instrument Return

Before returning an instrument to QuadTech for service please call our **Customer Care Center** (CCC) at **800-253-1230** for Return Material Authorization (RMA). It will be necessary to include a Purchase Order Number to insure expedient processing, although units found to be in warranty will be repaired at no-charge. For any questions on repair costs or shipping instructions please contact our CCC Department at the afore-mentioned number. To safeguard an instrument during storage and shipping, please use packaging that is adequate to protect it from damage, i.e. equivalent to the original packaging, and mark the box "Delicate Electronic Instrument". Return material should be sent freight prepaid to:

QuadTech, Inc. 5 Clock Tower Place, 210 East Maynard, Massachusetts 01754

Attention: RMA#

Shipments sent collect cannot be accepted.

### 4.3 Calibration

Calibration of the 1715 LCR Digibridge instruments is completed at the factory and includes a NIST calibration certificate. Verification of instrument operation and accuracy is recommended on an annual basis. Accurate operation of the 1715 instrument is confirmed using the 1715-TP Verification Procedure.

Service & Calibration Page 83 of 87

### **4.3.1 1715** Verification Procedure

This section outlines the relevant information to verify performance of the 1715 LCR Meter. It is recommended that performance be performed at least once a year using this outline procedure. Instrument should be warmed up for a minimum of 15 minutes prior to verification. Verification should be performed under the following conditions: Temperature equal to  $23^{\circ}\text{C} \pm 1.2^{\circ}\text{C}$  and Relative Humidity (RH) between 35% and 55%.

Recommended standards are listed below. All standards should be traceable to a National Laboratory such as N.I.S.T. with calibrated values for primary and secondary parameters at the required test frequencies. QuadTech's verification conforms to ANSI Z540 and QuadTech recommends that the calibrated values for the primary and secondary standards have an uncertainty 4 times better than the primary and secondary accuracy specified in the Verification Data Sheet. If the calibrated values for the standards used do not have an uncertainty of 4 times better than the specified accuracy of the 1715 the uncertainty of the standard should be added to the specified accuracy of the 1715. For example: if the calibrated value of the 500m $\Omega$  standard is 495.0m $\Omega$  ±1% at 100Hz, the expected reading on the 1715 would be 495.0 m $\Omega$  ±1.7% (1% for the standard accuracy plus 0.7% for the 1715 accuracy). This also applies for secondary parameters as well.

Primary and secondary accuracy specifications given in the Verification Data Sheet are based upon the accuracy formulas in section 2.4.5 of this manual.

### Measurement Standards

#### **Inductance Standards 4 Terminal**

Inductor 10 μH (nominal value)
Inductor 100 μH (nominal value)
Inductor 1000 μH (nominal value)

## Standard Open and Short

#### Resistance Standards 4 Terminal

Resistor 95K ohm (nominal value)
Resistor 6K ohm (nominal value)
Resistor 374 ohm (nominal value)
Resistor 25 ohm (nominal value)
Resistor 5 ohm (nominal value)
Resistor 500m ohm (nominal value)

### Capacitance Standards 2 or 4 Terminal

Capacitor 50pF (nominal value) Capacitor 100pF (nominal value) Capacitor 200pF (nominal value) Capacitor 500pF (nominal value) Capacitor 1000pF (nominal value) Capacitor 0.1µF (nominal value) Capacitor 0.05 µF (nominal value) Capacitor 0.02 µF (nominal value) Capacitor 0.01 µF (nominal value) Capacitor 0.002µF (nominal value)

Page 84 of 87 Interface

## Measurement Procedure

The 1715 should be set to the following:

# [MEAS DISPLAY]

Range: = Auto Level: 1Volt Speed: = Slow Trigger = Manual Binning = Off Compare = Off

Connections to all standards should be via a 1-meter cable.

A multiple frequency open and short correct should be performed prior to any measurements. See paragraph 2.5.5 for information on performing an open and short correction.

Connect each standard listed in the Verification Data Sheet and select the test frequency in the [MEAS DISPLAY] menu of the 1715. Record the results in the Verification Data Sheet.

## **4.3.2 1715** Verification Data Sheet

R500m		DC uncertainty +/-	50ppm					
Freq	Primary	Secondary	Voltage	Pmax	SMax	Pspec	Sspec	
100	0.49999824	0.000004	1			1.00%	0.0100	PASS
120	0.49999824	0.000005	1			0.80%	0.0080	PASS
1000	0.49999824	0.000039	1			0.80%	0.0080	PASS
10000	0.49999824	0.000389	1			1.20%	0.0120	PASS
R5		DC uncertainty +/-	50ppm					
Freq	Primary	Secondary	Voltage	Pmax	SMax	Pspec	Sspec	
100	4.99569941	0.000001	1			0.40%	0.0040	PASS
120	4.99569941	0.000001	1			0.30%	0.0030	PASS
1000	4.99569941	0.000009	1			0.25%	0.0025	PASS
10000	4.99569941	0.000085	1			0.30%	0.0030	PASS
R25		DC uncertainty +/-	50ppm					
Freq	Primary	Secondary	Voltage	Pmax	SMax	Pspec	Sspec	
100	24.9000072	0.000000	1			0.30%	0.0030	PASS
120	24.9000072	0.000000	1			0.25%	0.0025	PASS
1000	24.9000072	0.000003	1			0.20%	0.0020	PASS
10000	24.9000072	0.000027	1			0.20%	0.0020	PASS
R374		DC uncertainty +/-	50ppm					
Freq	Primary	Secondary	Voltage	Pmax	SMax	Pspec	Sspec	
100		0.000000	1			0.20%	0.0020	PASS
120	373.969269	0.000000	1			0.20%	0.0020	PASS
1000	373.969269	0.000000	1			0.20%	0.0020	PASS
10000	373.969269	-0.000001	1			0.20%	0.0020	PASS

Interface Page 85 of 87

R6K		DC uncertainty +/-	· 50ppm							
Freq	Primary	Secondary	Voltage	Pmax	SMax	Pspec	Sspec			
100	5968.78174	-0.000003	1			0.20%	0.0020	PASS		
120	5968.78174	-0.000003	1			0.20%	0.0020	PASS		
1000	5968.78174	-0.000029	1			0.20%	0.0020	PASS		
10000	5968.78125	-0.000286	1			0.20%	0.0020	PASS		
R95.3K		DC uncertainty +/-	- 50ppm							
Freq	Primary	Secondary	Voltage	Pmax	SMax	Pspec	Sspec			
100		-0.000034	1			0.40%	0.0040	PASS		
120	95299.547	-0.000041	1			0.30%	0.0030	PASS		
1000	95299.539	-0.000343	1			0.20%	0.0020	PASS		
10000	95298.422	-0.003433	1			0.60%	0.0061	PASS		
C50pF		uncertainty at 1kH	z primary +/-	0.025%, s	econdary	+/- 0.02				
Freq	Primary	Secondary	Voltage	Pmax	SMax	Pspec	Sspec			
1000	4.980E -11	0.000082	1			0.80%	0.0091	PASS		
10000	4.980E -11	0.000053	1			0.90%	0.0130	PASS		
C100pF		uncertainty at 1kH	Incertainty at 1kHz primary +/- 0.025%, secondary +/- 0.02							
Freq	Primary	Secondary	Voltage	Pmax	SMax	Pspec	Sspec			
1000		0.000046	1			0.80%		PASS		
10000	9.990E -11	0.000032	1			0.90%	0.013	PASS		
C200pF		uncertainty at 1kHz primary +/- 0.025%, secondary +/- 0.05								
Freq	Primary	Secondary	Voltage	Pmax	SMax	Pspec	Sspec			
100	1.995E -10	0.000100	1			2.50%		PASS		
120	1.995E -10	0.000087	1			1.00%	0.0105	PASS		
1000	1.995E -10	0.000028	1			0.40%	0.0046	PASS		
10000	1.995E -10	0.000021	1			0.60%	0.0087	PASS		
C500pF		uncertainty at 1kH	z primary +/-	0.01%, se	condary +	/- 100ppm				
Freq	Primary	Secondary	Voltage	Pmax	SMax	Pspec	Sspec			
100	4.9970E-10	0.000037	1			2.50%	0.0261	PASS		
120			1			1.00%				
1000	4.9970E-10	0.000008	1			0.40%	0.0046	PASS		
10000	4.9970E-10	0.000006	1			0.60%	0.0087	PASS		
C2nF		uncertainty at 1kHz primary +/- 0.01%, secondary +/- 100ppm								
Freq	Primary	Secondary	Voltage	Pmax	SMax	Pspec	Sspec			
100	1.9993E-09	0.000285	1			0.60%	0.0063	PASS		
120	1.9993E-09	0.000241	1			0.50%	0.0053	PASS		
1000	1.9993E-09	0.000047	1			0.20%	0.0023	PASS		
10000	1.9993E-09	0.000023	1			0.20%	0.0029	PASS		

Page 86 of 87

C10nF		uncertainty at 1kh	Hz primary +	/- 0.01%,	secondary	/ +/- 100ppr	n	
Freq	Primary	Secondary	Voltage	Pmax	SMax	Pspec	Sspec	
100	1.0001E-08	0.000073	1			0.60%	0.0063	PASS
120	1.0001E-08	0.000064	1			0.50%	0.0052	PASS
1000	1.0001E-08	0.000026	1			0.20%	0.0023	PASS
10000	1.0001E-08	0.000024	1			0.20%	0.0029	PASS
C20nF		uncertainty at 1kh	Iz primary +	/- 0.01%,	secondary	/ +/- 100ppr	n	
Freq	Primary	Secondary	Voltage	Pmax	SMax	Pspec	Sspec	
100	2.0004E-08	0.000047	1			0.40%	0.0042	PASS
120	2.0004E-08	0.000042	1			0.30%	0.0031	PASS
1000	2.0004E-08	0.000023	1			0.20%	0.0023	PASS
10000	2.0004E-08	0.000027	1			0.20%	0.0029	PASS
C50nF		uncertainty at 1kH	- Hz primary +	/- 0.01%,	secondary	/ +/- 100ppr	m	
Freq	Primary	Secondary	Voltage	Pmax	SMax	Pspec	Sspec	
100	5.0004E-08	0.000031	1			0.40%	0.0042	PASS
120	5.0004E-08	0.000029	1			0.30%	0.0031	PASS
1000	5.0004E-08	0.000023	1			0.20%	0.0023	PASS
10000	5.0004E-08	0.000036	1			0.20%	0.0029	PASS
C100nF		uncertainty at 1kH	Iz primary +	/- 0.01%,	secondary	/ +/- 100ppr	n	
Freq	Primary	Secondary	Voltage	Pmax	SMax	Pspec	Sspec	
100	1.0001E-07	0.000026	1			0.40%	0.0042	PASS
120	1.0001E-07	0.000025	1			0.30%	0.0031	PASS
1000	1.0001E-07	0.000024	1			0.20%	0.0023	PASS
10000	1.0001E-07	0.000051	1			0.20%	0.0029	PASS
L10uH		uncertainty at 1kh	Iz primary +	/- 0.01%,	secondary	/ +/- 100ppr	n	
Freq	Primary	Secondary	Voltage	Pmax	SMax	Pspec	Sspec	
10000	9.9996E-06	52.619293	1			1.20%	34.22	PASS
L100uH		uncertainty at 1kh	- Iz primary +	/- 0.01%,	secondary	/ +/- 100ppr	m	
Freq	Primary	Secondary	Voltage	Pmax	SMax	Pspec	Sspec	
1000	1.0027E-04	2.4351	1			1.13%	0.1240	PASS
10000	1.0027E-04	24.2989	1			0.30%	2.3426	PASS
L1000uH		uncertainty at 1kh	Iz primary +	/- 0.01%,	secondary	/ +/- 100ppr	m	
Freq	Primary	Secondary	Voltage	Pmax	SMax	Pspec	Sspec	
100		0.7682	1			2.30%	· ·	PASS
120	9.9933E-04	0.9218	1			1.67%	0.0406	PASS
1000	9.9933E-04	7.6794	1			0.28%	0.3228	PASS
10000	9.9943E-04	74.2633	1			0.20%	12.67	PASS

Interface Page 87 of 87